PPCBug
Diagnostics Manual

PPCDIAA/UM1

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Preface

The *PPCBug Diagnostics Manual* provides general information, installation procedures, and a diagnostic firmware guide for the PPC1Bug Debugging Package. All information contained herein is specific to Motorola's PowerPC™-based boards: MVME230x VME Processor Modules, MVME260x Single Board Computers, MVME360x VME Processor Modules, MVME460x VME Dual Processor Modules, and MTX Embedded ATX Motherboards. In this manual, they are collectively referred to as the *PowerPC board* or *board*. When necessary to refer to them individually, they are called the MVME230*x*, MVME260*x*, MVME360*x*, MVME460*x*, and MTX.

This manual covers release 3.3 of PPC1Bug, dated 06/20/97.

Use of the PPCBug debugger, the debugger command set, the one-line assembler/disassembler, and system calls for the debugging package are all described in the two-volume *PPCBug Firmware Package User's Manual (PPCBUGA1/UM3 and PPCBUGA2/UM3)*.

Refer also to the lists of publications in Appendix A, *Related Documentation*, for other documents that may provide helpful information.

This manual is intended for anyone who wants to design OEM systems, supply additional capability to an existing compatible system, or work in a lab environment for experimental purposes. A basic knowledge of computers and digital logic is assumed.

Conventions

The following conventions are used in this document:

bold	is used for user input that you type just as it appears. Bold is also used for commands, options and arguments to commands, and names of programs, directories, and files.
italic	is used for names of variables to which you assign values. Italic is also used for comments in screen displays and examples.
`courier`	is used for system output (e.g., screen displays, reports), examples, and system prompts.
RETURN	represents the "carriage return" or **ENTER** key.
CTRL	represents the control key. Execute control characters by pressing the **CTRL** key and the letter simultaneously, e.g., **CTRL-d**.

Manual Terminology

Throughout this manual, a convention has been maintained whereby data and address parameters are preceded by a character which specifies the numeric format as follows:

$	dollar	specifies a hexadecimal character
0x	Zero-x	
%	percent	specifies a binary number
&	ampersand	specifies a decimal number

Unless otherwise specified, all address references are in hexadecimal throughout this manual.

An asterisk (*) following the signal name for signals which are *level significant* denotes that the signal is *true* or valid when the signal is low.

An asterisk (*) following the signal name for signals which are *edge significant* denotes that the actions initiated by that signal occur on high to low transition.

In this manual, *assertion* and *negation* are used to specify forcing a signal to a particular state. In particular, *assertion* and *assert* refer to a signal that is active or *true*; *negation* and *negate* indicate a signal that is inactive or *false*. These terms are used independently of the voltage level (high or low) that they represent.

For PPCBug, data and address sizes are defined as follows:

- A *byte* is eight bits, numbered 0 through 7, with bit 0 being the least significant.
- A *halfword* is 16 bits, numbered 0 through 15, with bit 0 being the least significant.
- A *word* is 32 bits, numbered 0 through 31, with bit 0 being the least significant.

In addition, commands that act on halfwords or words over a range of addresses may truncate the selected range so as to end on a properly aligned boundary.

Safety Summary
Safety Depends On You

The following general safety precautions must be observed during all phases of operation, service, and repair of this equipment. Failure to comply with these precautions or with specific warnings elsewhere in this manual violates safety standards of design, manufacture, and intended use of the equipment. Motorola, Inc. assumes no liability for the customer's failure to comply with these requirements.

The safety precautions listed below represent warnings of certain dangers of which Motorola is aware. You, as the user of the product, should follow these warnings and all other safety precautions necessary for the safe operation of the equipment in your operating environment.

Ground the Instrument.

To minimize shock hazard, the equipment chassis and enclosure must be connected to an electrical ground. The equipment is supplied with a three-conductor AC power cable. The power cable must be plugged into an approved three-contact electrical outlet. The power jack and mating plug of the power cable meet International Electrotechnical Commission (IEC) safety standards.

Do Not Operate in an Explosive Atmosphere.

Do not operate the equipment in the presence of flammable gases or fumes. Operation of any electrical equipment in such an environment constitutes a definite safety hazard.

Keep Away From Live Circuits.

Operating personnel must not remove equipment covers. Only Factory Authorized Service Personnel or other qualified maintenance personnel may remove equipment covers for internal subassembly or component replacement or any internal adjustment. Do not replace components with power cable connected. Under certain conditions, dangerous voltages may exist even with the power cable removed. To avoid injuries, always disconnect power and discharge circuits before touching them.

Do Not Service or Adjust Alone.

Do not attempt internal service or adjustment unless another person, capable of rendering first aid and resuscitation, is present.

Use Caution When Exposing or Handling the CRT.

Breakage of the Cathode-Ray Tube (CRT) causes a high-velocity scattering of glass fragments (implosion). To prevent CRT implosion, avoid rough handling or jarring of the equipment. Handling of the CRT should be done only by qualified maintenance personnel using approved safety mask and gloves.

Do Not Substitute Parts or Modify Equipment.

Because of the danger of introducing additional hazards, do not install substitute parts or perform any unauthorized modification of the equipment. Contact your local Motorola representative for service and repair to ensure that safety features are maintained.

Dangerous Procedure Warnings.

Warnings, such as the example below, precede potentially dangerous procedures throughout this manual. Instructions contained in the warnings must be followed. You should also employ all other safety precautions which you deem necessary for the operation of the equipment in your operating environment.

WARNING

Dangerous voltages, capable of causing death, are present in this equipment. Use extreme caution when handling, testing, and adjusting.

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General Information 1

Introduction

This manual describes the complete set of hardware diagnostics included in the PPCBug Debugging Package, intended for testing and troubleshooting of Motorola's PowerPC-based boards. This member of the PPCBug firmware family, known as PPCBug diagnostics, is implemented on these Motorola PowerPC-based products:

- MVME230x VME Processor Modules
- MVME260x Single Board Computers
- MVME360x VME Processor Modules
- MVME460x VME Dual Processor Modules
- MTX Embedded ATX Motherboards

They are collectively referred to in this manual as the *PowerPC board* or *board*. When necessary to refer to them individually, they are called the MVME230*x*, MVME260*x*, MVME360*x*, MVME460*x*, and MTX respectively.

This introductory chapter includes information about the operation and use of the diagnostics. Chapter 2 contains descriptions of the diagnostic utilities. Chapter 3 contains descriptions of the diagnostic test routines.

Before using the PPCBug diagnostics, you should ensure that your PowerPC board and other hardware have been properly configured and connected, according to the installation guide for your PowerPC board. You also need the two-volume manual for the PPCBug Debugging Package, *PPCBug Firmware Package User's Manual*. It contains a complete description of PPCBug, the start-up procedure, descriptions of all general software debugging commands, and other information you need to know about the debugger.

Overview of PPCBug Firmware

The PPCBug firmware consists of three parts:

- A command-driven, user-interactive *software debugger*, described in the *PPCBug Firmware Package User's Manual*.
- A command-driven *diagnostics package* for the PowerPC board hardware, described in this manual. The diagnostic firmware contains a battery of utilities and tests for exercise, test, and debug of hardware in the PowerPC board environment. The diagnostics are menu-driven for ease of use.
- A *user interface* or *debug/diagnostics monitor* that accepts commands from the system console terminal. The tests described in this manual are called, commands are input, and results reported via this monitor, the common system monitor used for the debugger and the diagnostics. The monitor is command-line driven and provides input/output facilities, command parsing, error reporting, interrupt handling, and a multi-level directory for menu selection.

Debugger and Diagnostic Directories

When using PPCBug, you operate out of either the debugger directory or the diagnostic directory:

- If you are in the debugger directory, the debugger prompt `PPC1-Bug>` is displayed and you have all of the debugger commands at your disposal.
- If you are in the diagnostic directory, the diagnostic prompt `PPC1-Diag>` is displayed and you have all of the diagnostic commands at your disposal as well as all of the debugger commands.

To use the diagnostics, you must be in the diagnostic directory. If the prompt `PPC1-Bug>` is displayed, you are in the debugger directory and must switch to the diagnostic directory by entering **SD**, the debugger's Switch Directories command. The diagnostic prompt `PPC1-Diag>` is then be displayed.

You may examine the commands in the particular directory that you are currently in by using the Help (**HE**) command.

Because PPCBug is command-driven, it performs various operations in response to commands that you enter at the keyboard. PPCBug executes the command and the prompt reappears. However, if you enter a command that causes execution of user target code (e.g., **GO**), then control may or may not return to PPCBug, depending on the outcome of the user program.

The Help (**HE**) command displays a menu of all available diagnostic functions; i.e., the tests and utilities. Several tests have a subtest menu which may be called using the **HE** command. In addition, some utilities have subfunctions, and as such have subfunction menus.

Command Entry

Enter the name of a diagnostic command when the prompt `PPC1-Diag>` appears, and then press the **RETURN** or **ENTER** key.

The command may be the name of a diagnostic utility routine and may include one or more arguments; or it may be the name of one or more test groups listed in a main (root) directory and may include one or more subcommands (individual test names) listed in the subdirectory for a particular test group.

The utility routines are described in Chapter 2. The test groups are described in Chapter 3. Examples of command entry for both are given below.

Root-Level Command (Utility):

The utility or root-level commands affect the operation of the tests that are subsequently run. A test group name may be entered on the same command line. For example:

```
PPC1-Diag>CF RAM
```

causes an interactive dialog to begin, in which you may enter parameters for the **RAM** tests.

Command entry may also include a subcommand (individual test name). For example:

```
PPC1-Diag>HE DEC2 ERREN
```

causes a help screen to appear that gives information about the **ERREN** test in the **DEC** test group.

Root-Level Command (Test Group):

Entering just the name of a test group causes all individual tests that are part of that group to execute in sequence (with some exceptions). For example:

```
PPC1-Diag>RAM
```

causes all Random Access Memory (**RAM**) tests to execute, except for two that only execute if specified.

Subdirectory-Level Command (Individual Test):

Entering the name of a test group followed by the name of an individual test from that group causes just that test to execute.

For example, to call up a particular Random Access Memory (**RAM**) test, enter:

```
PPC1-Diag>RAM ADR
```

This causes the monitor to find the **RAM** test group subdirectory, and then to execute the Memory Addressing test command **ADR** from that subdirectory.

To call up a particular **DEC** test, enter:

```
PPC1-Diag>DEC REGA
```

This causes the monitor to find the **DEC** test group subdirectory, and then to execute the PCI Register Access command **REGA** from that subdirectory.

Multiple Subdirectory-Level Commands (Individual Tests):

If the first part of a command is a test group name, any number and/or sequence of tests from that test group may be entered after the test group name so long as the debugger's input buffer size limit is not exceeded. For example:

```
PPC1-Diag>RAM PATS ADR
```

This causes both the Data Patterns (**PATS**) and the Memory Addressing (**ADR**) tests from the **RAM** test group to execute.

Multiple Root-Level Commands (Test Groups):

Multiple commands may be entered. If a command expects parameters and another command is to follow it, separate the two with a semicolon (**;**).

For example, to invoke the command **RTC CLK** (to execute the Real Time Clock Function test from the MK48Txx Real Time Clock test group) after the command **RAM ADR**, the command line would read:

```
PPC1-Diag>RAM ADR; RTC CLK
```

Spaces are not required before or after the semicolon but are shown here for legibility. Spaces are required between commands and their arguments. Several commands may be combined on one line.

Installation, Configuration, and Start-Up

The PPCBug firmware is installed by Motorola at the factory when your PowerPC board is manufactured.

Refer to your PowerPC board installation manual and ensure that all necessary hardware preparation, board installation, connection of peripherals, and hardware configuration, including console selection and configuration of Software Readable Headers (where applicable), has been correctly done.

After your hardware has been set up according the installation manual, refer to the *PPCBug Firmware Package User's Manual* for the start-up procedure before powering up the system.

Diagnostic Utilities 2

Introduction

This chapter contains descriptions and examples of the various diagnostic utilities available in PPCBug.

Utilities

In addition to individual or sets of tests, the diagnostic package supports the utilities (root-level commands or general commands) listed in the table below and described on the following pages.

Table 2-1. Diagnostic Utilities

Command	Description
AEM	Append Error Messages Mode
CEM	Clear Error Messages
CF	Test Group Configuration Parameters Editor
DE	Display Error Counters
DEM	Display Error Messages
DP	Display Pass Count
HE	Help
HEX	Help Extended
LA	Loop Always Mode
LC	Loop-Continue Mode
LE	Loop-On-Error Mode
LF	Line Feed Suppression Mode
LN	Loop Non-Verbose Mode
MASK	Display/Revise Self Test Mask
NV	Non-Verbose Mode
QST	Quick Self Test
SD	Switch Directories

Table 2-1. Diagnostic Utilities (Continued)

Command	Description
SE	Stop-On-Error Mode
ST	Self Test
ZE	Clear (Zero) Error Counters
ZP	Zero Pass Count

Notes You may enter command names in either uppercase or lowercase.

Terminate all command lines by pressing the **RETURN** key.

AEM - Append Error Messages Mode

The **AEM** command allows you to accumulate error messages in the internal error message buffer of the diagnostic monitor.

This command sets the internal append error messages flag of the diagnostic monitor. The default of the internal append error messages flag is clear. The internal flag is not set until it is encountered in the command line by the diagnostic monitor.

The contents of the buffer can be displayed with the **DEM** command.

When the internal append error messages flag has not been set or has been cleared with **CEM**, the diagnostic error message buffer is erased (cleared of all character data) before each test is executed.

The duration of this command is for the life of the command line being parsed by the diagnostic monitor.

Example:

```
PPC1-Diag>aem; ram ref
RAM   REF: Memory Refresh Test..... Running ---> FAILED
```

(error message written to error message buffer)

```
PPC1-Diag>
```

CEM - Clear Error Messages

This command allows you to clear the internal error message buffer of the diagnostic monitor manually.

Example:

```
PPC1-Diag>cem
    (error message buffer is cleared)
PPC1-Diag>
```

CF - Test Group Configuration Parameters Editor

The **CF** parameters control the operation of all tests in a test group.

For example, the **RAM** test group has parameters such as starting address, ending address, parity enable, etc. At the time of initial execution of the diagnostic monitor, the default configuration parameters are copied from the firmware into the debugger work page. Here you can modify the configuration parameters via the **CF** command.

When you invoke the **CF** command, you are interactively prompted with a brief parameter description and the current value of the parameter. You may enter a new value for that parameter, or a **RETURN** to accept the current value and proceed to the next configuration parameter. To discontinue the interactive process, enter a period (**.**) followed by **RETURN**.

You may specify one or more test groups as argument(s) immediately following the **CF** command on the command line. If no arguments follow the **CF** command, the parameters for all test groups are presented so you may change them if you wish.

Examples:

```
PPC1-Diag>cf
RAM Configuration Data:
Starting/Ending Address Enable [Y/N] =N ?RETURN
Starting Address =00004000 ?RETURN
Ending Address   =00F84FFC ?RETURN
```

```
Random Data Seed =12301983 ?RETURN
March Address Pattern =00000000 ?RETURN
Instruction (Code) Cache Enable [Y/N] =Y ? .RETURN
PPC1-Diag>cf scc
SCC Configuration Data:
SCC Memory Space Base Address          =80000840 ? RETURN
Internal-Loopback/Baud-Rates Port Mask   =00000003 ? RETURN
External-Loopback/Modem-Control Port Mask =00000003 ?RETURN
PPC1-Diag>
```

DE - Display Error Counters

Each test or command in the diagnostic monitor has an individual error counter. As errors are encountered in a particular test, that error counter is incremented. If you were to run a self test or just a series of tests, the results could be broken down as to which tests passed by examining the error counters.

To display all error counters after the conclusion of a test, enter **DE**. **DE** displays the results of a particular test if the name of that test follows **DE**. Only nonzero values are displayed.

Example:

```
PPC1-Diag>de ram addr
PPC1-Diag>
```

DEM - Display Error Messages

This command allows you to display (dump) the internal error message buffer of the diagnostic monitor manually.

Example:

```
PPC1-Diag>dem

    (contents of error message buffer are displayed)

PPC1-Diag>
```

DP - Display Pass Count

A count of the number of passes in Loop-Continue (**LC**) mode is kept by the monitor. This count is displayed with other information at the conclusion of each pass. To display this information without using **LC**, enter **DP**.

Example:

```
PPC1-Diag>dp
Pass Count =19
PPC1-Diag>
```

HE - Help

The Help command provides on-line documentation. Entering **HE** at the diagnostics prompt (`PPC1-Diag>`) displays a menu of the top level directory of utility commands and test group names if no parameters are entered, or the menu of a subdirectory if the name of that subdirectory, or test group name, is entered following **HE**.

The display of the top level directory lists `"(DIR)"` after the name of each command that has a subdirectory.

Note If **HE** is entered to the debugger prompt (`PPC1-Bug>`), the debugger commands will be displayed.

Examples:

To display the menu of all utility and test group names, enter:

```
PPC1-Diag>he
```

(see Figure 2-1)

When a menu is too long to fit on the screen, it pauses until you press **RETURN** again.

```
PPC1-Diag>he
AEM       Append Error Messages Mode
CEM       Clear Error Messages
CF        Configuration Editor
CL1283    Parallel Interface (CL1283) Tests (DIR)
CS4231    cs4231 Audio Codec (DIR)
DE        Display Errors
DEC       Ethernet Controller (DEC21x40) Tests (DIR)
DEM       Display Error Messages
DP        Display Pass Count
HE        Help on Tests/Commands
HEX       Help Extended
ISABRDGE  ISA Bridge Tests (DIR)
KBD8730X  Keyboard/Mouse Controller Tests (DIR)
L2CACHE   L2-Cache (DIR)
LA        Loop Always Mode
LC        Loop Continuous Mode
LE        Loop on Error Mode
LF        Line Feed Mode
LN        Loop Non-Verbose Mode
MASK      Self Test Mask
NCR       NCR 53C8XX SCSI I/O Processor Tests (DIR)
NV        Non-Verbose Mode
PAR8730X  Parallel Interface (PC8730x) Tests (DIR)
PCIBUS    PCI/PMC Generic
Press "RETURN" to continue
RETURN
```

Figure 2-1. Help Screen (Sheet 1 of 2)

```
QST      Quick Self Test (DIR)
RAM      Random Access Memory Tests (DIR)
RTC      MK48Txx Timekeeping (DIR)
SCC      Serial Communication Controller(Z85C230)Tests (DIR)
SE       Stop on Error Mode
ST       Self Test (DIR)
UART     Serial Input/Output Tests (DIR)
VGA543X VGA Controller (GD543X) Tests (DIR)
VME2     VME2Chip2 Tests (DIR)
Z8536    z8536 Counter/Timer Input/Output Tests (DIR)
ZE       Zero Errors
ZP       Zero Pass Count
PPC1-Diag>
```

Figure 2-1. Help Screen (Sheet 2 of 2)

To bring up a menu of all the RAM memory tests, enter:

```
PPC1-Diag>he ram
RAM      Random Access Memory Tests (DIR)
ADR      Addressability
ALTS     Alternating Ones/Zeroes
BTOG     Bit Toggle
CODE     Code Execution/Copy
MARCH    March Address
PATS     Patterns
PED      Local Parity Memory Error Detection
PERM     Permutations
QUIK     Quick Write/Read
REF      Memory Refresh Test
RNDM     Random Data
PPC1-Diag>
```

To review a description of an individual test, enter the full name:

```
PPC1-Diag>he ram code
RAM      Random Access Memory Tests (DIR)
CODE     Code Execution/Copy
PPC1-Diag>
```

This displays information on the RAM Code Execution/Copy test routine.

HEX - Help Extended

The **HEX** command goes into an interactive, continuous mode of the **HE** command.

The prompt displayed for **HEX** is the question mark (**?**). You may then type the name of a directory or command. You must type **QUIT** to exit.

Example:

```
PPC1-Diag>HEX
Extended Help, Type <QUIT> to Exit
? lc
LC      Loop Continuous Mode
? ISABRDGE irq
ISABRDGE   ISA Bridge Tests (DIR)
IRQ     Interrupt Request
? quit
PPC1-Diag>
```

LA - Loop Always Mode

To repeat a test or series of tests endlessly, enter the prefix **LA**. The **LA** command modifies the way that a failed test is endlessly repeated.

The **LA** command has no effect until a test failure occurs, at which time, if the **LA** command has been previously encountered in the user command line, the failed test is endlessly repeated. To break the loop, press the **BREAK** key on the diagnostic video display terminal.

Certain tests disable the **BREAK** key interrupt, so it may become necessary to press the abort or reset switches on the PowerPC board front panel.

Example:

```
PPC1-Diag>la;ram adr
RAM   ADR: Addressability..... Running ---> PASSED
```

*(no errors detected so **LA** is ignored)*

```
PPC1-Diag>
```

LC - Loop-Continue Mode

To repeat a test or series of tests endlessly, enter the prefix **LC**. This loop includes everything on the command line.

To break the loop, press the **BREAK** key on the diagnostic video display terminal. Certain tests disable the **BREAK** key interrupt, so it may become necessary to press the abort or reset switches on the PowerPC board front panel.

Example:

```
PPC1-Diag>lc;ram adr
RAM  ADR: Addressability.................. Running ---> PASSED
Pass Count =1, Errors This Pass =0, Total Errors =0
RAM  ADR: Addressability.................. Running ---> PASSED
Pass Count =2, Errors This Pass =0, Total Errors =0
RAM  ADR: Addressability.................. Running ---> PASSED
Pass Count =3, Errors This Pass =0, Total Errors =0
RAM  ADR: Addressability.................. Running ---> <BREAK>
--Break Detected--
PPC1-Diag>
```

LE - Loop-On-Error Mode

Occasionally, when an oscilloscope or logic analyzer is in use, it becomes desirable to repeat a test endlessly (loop) while an error is detected. The **LE** command modifies the way a failed test is endlessly repeated.

The **LE** command has no effect until a test failure occurs, at which time, if the **LE** command has been previously encountered in the user command line, the failed test is re-executed as long as the previous execution returns failure status.

To break the loop, press the **BREAK** key on the diagnostic video display terminal. Certain tests disable the **BREAK** key interrupt, so it may become necessary to press the abort or reset switches on the PowerPC board front panel.

Example:

```
PPC1-Diag>le;scc
SCC   ACCESS: Device/Register Access...... Running ---> PASSED
SCC   IRQ: Interrupt Request.............. Running ---> FAILED

SCC/IRQ Test Failure Data:
(error message)

SCC   IRQ: Interrupt Request.............. Running ---> FAILED

SCC/IRQ Test Failure Data:
(error message)

SCC   IRQ: Interrupt Request.............. Running --->
<BREAK>
--Break Detected--
PPC1-Diag>
```

LF - Line Feed Suppression Mode

Entering **LF** on a command line sets the internal line feed mode flag of the diagnostic monitor. The duration of the **LF** command is the life of the user command line in which it appears.

The default state of the internal line feed mode flag is clear, which causes the executing test title/status line(s) to be terminated with a line feed character (scrolled).

The line feed mode flag is normally used by the diagnostic monitor when executing a System Mode self test. Although rarely invoked as a user command, the **LF** command is available to the diagnostic user.

Example:

```
PPC1-Diag>LF;RAM
RAM   ADR: Addressability................ Running ---> PASSED
```

(display of subsequent RAM test messages overwrite this line)

```
PPC1-Diag>
```

LN - Loop Non-Verbose Mode

The **LN** command modifies the way a failed test is endlessly repeated.

The **LN** command has no effect until a test failure occurs, at which time, if the **LN** command has been previously encountered in the user command line, further printing of the test title and pass/fail status is suppressed. This is useful for more rapid execution of the failing test; i.e., the **LN** command contributes to a "tighter" loop.

Example:

```
PPC1-Diag>LN;RAM ADR
RAM ADR: RAM  ADR: Addressability........ Running ---> PASSED
Pass Count =1, Errors This Pass =0, Total Errors =0
RAM  ADR: Addressability................. Running ---> PASSED
Pass Count =2, Errors This Pass =0, Total Errors =0
RAM  ADR: Addressability................. Running ---> PASSED
Pass Count =3, Errors This Pass =0, Total Errors =0
RAM  ADR: Addressability................. Running ---> <BREAK>
--Break Detected--
PPC1-Diag>
```

MASK - Display/Revise Self Test Mask

Using **MASK** with an argument enables/disables the specified test from running under self test. The argument must be a specific test name. If **mask** is invoked without arguments, the current self test mask, showing disabled tests, is displayed.

The **mask** command is a "toggle" command -- if the specified test name mask was set, it will be reset; if it was reset, it will be set. After the toggle, the new self test mask is displayed.

If the **mask** command is invoked with an invalid test name or a test directory (as opposed to a specific test name), an appropriate error message is output.

When the **mask** command is used on a PowerPC board system, the mask values are preserved in non-volatile memory. This allows the system to be completely powered down without disturbing the self test mask.

Example:

```
PPC1-Diag>mask ram adr
Update Non-Volatile RAM (Y/N)? y
RAM/ADR
PPC1-Diag>mask
RAM/ADR
PPC1-Diag>
```

NV - Non-Verbose Mode

Upon detecting an error, the tests display a substantial amount of data. To avoid the necessity of watching the scrolling display, you can choose a mode that suppresses all messages except test name and PASSED or FAILED. This mode is called *non-verbose* and you can invoke it prior to calling a command by entering **NV**.

Example:

```
PPC1-Diag>nv;uart lpbke
UART LPBKE:External Loopback .......Running --> FAILED
PPC1-Diag>
```

NV causes the monitor to run the UART external loopback test, but show only the name of the test and the results (pass/fail).

```
PPC1-Diag>uart lpbke
UART LPBKE:External Loopback .......Running --> FAILED

UART/LPBKE Test Failure Data:
RTS loopback to CTS or RI Failed: COM2

PPC1-Diag>
```

Without **nv**, the failure data is displayed.

SD - Switch Directories

The **SD** command allows you to switch back and forth between PPCBug's diagnostic directory (the prompt reads PPC1-Diag>) and the debug directory (the prompt reads PPC1-Diag>).

If you are in the diagnostic directory and enter **SD**, you will return to the debug directory. At this point, only the debug commands for PPC1Bug can be entered.

If you are in the debug directory and enter **SD**, you will return to the diagnostic directory. You may enter either the diagnostic or debug commands from the diagnostics directory.

Example:

```
PPC1-Diag>sd
PPC1-Bug>sd
PPC1-Diag>
```

SE - Stop-On-Error Mode

Sometimes you may want to stop a test or series of tests at the point where an error is detected. **SE** accomplishes that for most of the tests. To invoke **SE**, enter it before the test or series of tests that is to run in Stop-On-Error mode.

Example:

```
PPC1-Diag>se; dec ior ilr; scc dma irq
DEC IOR:I/O Resource Register Access...Running --> PASSED
DEC ILR:Interrupt Line Register Access.Running --> PASSED
SCC      DMA: DMA Test..................... Running --> FAILED
(error message)
```

(error encountered in DMA test so IRQ test not run)

```
PPC1-Diag>
```

2

ST and QST - Self Test and Quick Self Test

The diagnostics monitor provides an automated test mechanism called *self test*. This mechanism runs all the tests included in an internal self test directory.

Entering the **QST** command executes the suite of self tests that are run at start-up. Entering **ST** causes more tests to execute than does **QST**, but also requires more test time.

The commands **HE ST** and **HE QST** list the top level commands of the self test directory in alphabetical order. Each test for that particular command is listed in the section pertaining to the command.

For details on extended self test operation, refer to the *PPCBug Firmware Package User's Manual*.

Example:

```
PPC1-Diag>qst
RAM     ADR: Addressability.............. Running ---> PASSED
UART REGA: Register Access............... Running ---> PASSED
UART IRQ: Interrupt...................... Running ---> PASSED
UART BAUD: Baud Rate..................... Running ---> PASSED
UART LPBK: Internal Loopback............. Running ---> PASSED
Z8536   CNT: Counter..................... Running ---> PASSED
Z8536   LNK: Linked Counter.............. Running ---> PASSED
Z8536   IRQ: Interrupt................... Running ---> PASSED
```

(all tests in quick self test directory are run)

```
PPC1-Diag>
```

ZE - Clear (Zero) Error Counters

The error counters originally come up with the value of zero, but it is occasionally desirable to reset them to zero at a later time. This command resets all of the error counters to zero.

Example:

```
PPC1-Diag>ze
PPC1-Diag>
```

This clears all error counters.

ZP - Zero Pass Count

Invoking the **ZP** command resets the pass counter to zero. This is frequently desirable before typing in a command that invokes the Loop-Continue mode. Entering this command on the same line as **LC** results in the pass counter being reset on every pass.

Example:

```
PPC1-Diag>lc;ram adr ;zp
RAM  ADR: Addressability..... Running ---> PASSED

Pass Count =1, Errors This Pass =0, Total Errors =0
RAM  ADR: Addressability..... Running ---> PASSED

Pass Count =1, Errors This Pass =0, Total Errors =0
RAM  ADR: Addressability..... Running ---> PASSED

Pass Count =1, Errors This Pass =0, Total Errors =0
RAM  ADR: Addressability..... Running --->
<BREAK>
--Break Detected--
PPC1-Diag>
```

Test Descriptions 3

Detailed descriptions of PPCBug's diagnostic tests are presented in this chapter. The test groups are described in the order shown in the following table. Note that some test groups do not run on all PowerPC boards. The column *PowerPC Board* lists the boards on which each group of tests will run.

Table 3-1. Diagnostic Test Groups

Test Group	Description	PowerPC Board
CL1283	Parallel Interface (CL1283) Tests	MTX
DEC	DEC21*x*40 Ethernet Controller Tests	All
ISABRDGE	PCI/ISA Bridge Tests	All
KBD8730X	PC8730x Keyboard/Mouse Tests	All
L2CACHE	Level 2 Cache Tests	All
NCR	NCR 53C8xx SCSI2 I/O Processor Tests	All
PAR8730X	Parallel Interface (PC8730x) Tests	All
UART	Serial Input/Output Tests	All
PCIBUS	PCI/PMC Generic Tests	All
RAM	Local RAM Tests	All
RTC	MK48Txx Timekeeping Tests	All
SCC	Serial Communication Controller (Z85C230) Tests	All except MVME230*x*
VGA543X	Video Diagnostics Tests	MVME360*x*, MVME460*x*
VME2	VMEchip2 VME Interface ASIC Tests	None
Z8536	Z8536 Counter/Timer Tests	All except MVME230*x*

Notes 1. You may enter command names in either uppercase or lowercase.

2. Some diagnostics depend on restart defaults that are set up only in a particular restart mode. Refer to the documentation on a particular diagnostic for the correct mode.

CL1283 - Parallel Interface Tests

This section describes the CL1283 parallel Interface (CL1283) tests.

Note

These tests apply only to the MTX boards. They are not available on the other PowerPC boards: MVME230*x*, MVME260*x*, MVME360*x*, MVME460*x*, and PMCspan.

Entering **CL1283** without parameters causes all **CL1283** tests to execute in the order shown in the following table.

To run an individual test, add that test name to the **CL1283** command.

The individual tests are described in alphabetical order on the following pages.

Table 3-2. CL1283 Test Group

Name	Description
REG	Register

REG - Register

Command Input

```
PPC1-Diag>CL1283 REG
```

Description

This test verifies that the CL1283 registers can be read and written. Data patterns verify that every read/write bit can be modified.

Response/Messages

After the command has been issued, the following line is printed:

```
CL1283 REG: cl1283 Register Access...... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
CL1283 REG: cl1283 Register Access...... Running ---> PASSED
```

If the board does not support the CL1283, the following is displayed:

```
CL1283 REG: cl1283 Register Access...... Running ---> BYPASSED
```

If any failures occur, the following is displayed (more descriptive text then follows):

```
CL1283 REG: cl1283 Register Access...... Running ---> FAILED
```

If the test fails because the pattern written does not match the one read back from the CL1283 register, the following is printed:

```
CS4231 INDIRECT:Local Parity Memory Detection..Running --> FAILED

cl1283 Register: xxx, Expected bit#_ to be high/low, Actual reg value xx
```

DEC - Ethernet Controller Tests

These sections describe the individual DEC21*x*40 Ethernet Controller tests.

Entering **DEC** without parameters causes all **DEC** tests to run in the order shown in the table below, except as noted.

To run an individual test, add that test name to the **DEC** command.

The individual tests are described in alphabetical order on the following pages.

Table 3-3. DEC Test Group

Name	Description
REGA	Register Access
XREGA	Extended Register Access
SPACK	Single Packet Transmit and Receive
ILR	Interrupt Line Register Access
ERREN	PERREN and SERREN Bit Toggle
IOR	I/O Resource Register Access
CINIT	Chip Initialization
Executed only when specified:	
CLOAD	Continuous Load
CNCTR	Connector

None of these tests need any external hardware hooked up to the Ethernet port with the exception of the **CNCTR** test, which needs external loopback “plugs” in the external connector.

CINIT - Chip Initialization

Command Input

```
PPC1-Diag>dec cinit
```

Description

This test checks the DEC chip initialization sequence for proper operation while using interrupts and reading the initialization blocks and rings structures used for Ethernet communications.

Response/Messages

After the command has been issued, the following line is printed:

```
DEC CINIT: Chip Initialization:.........Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
DEC CINIT: Chip Initialization:.........Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
DEC CINIT: Chip Initialization:.........Running ---> FAILED

DEC/CINIT Test Failure Data:
(error message)
```

Refer to the section *DEC Error Messages* for a list of the error messages and their meaning.

CLOAD - Continuous Load

Command Input

```
PPC1-Diag>DEC CLOAD
```

Description

This test verifies that a continuous load can be placed on the controller by transmitting/receiving a sequence of packets totalling at least 1 megabyte of throughput, comparing the input data with the output data.

Response/Messages

After the command has been issued, the following line is printed:

```
DEC CLOAD: Continuous Load:.............Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
DEC CLOAD: Continuous Load:.............Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
DEC CLOAD: Continuous Load:.............Running ---> FAILED

DEC/ClOAD Test Failure Data:
(error message)
```

Refer to the section *DEC Error Messages* for a list of the error messages and their meaning.

CNCTR - Connector

Command Input

```
PPC1-Diag>dec cnctr
```

Description

This test verifies that the data path through the external (AUI or TP (twisted pair)) connection is functional, by transmitting and receiving packets and comparing the data. This test requires the presence of an external loopback "plug" for AUI or TP.

Note It is recommended that the board under test not be connected to a live network while this test is running. The suggested "loopback" setup for AUI is an AUI-to-thinnet transceiver attached to a BNC tee with terminators on each arm of the tee. For TP setup, an external shunt needs to be put in the TP socket (it cannot be connected to a live network).

Response/Messages

After the command has been issued, the following line is printed:

```
DEC CNCTR: Connector:..................Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
DEC CNCTR: Connector:..................Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
DEC CNCTR: Connector:..................Running ---> FAILED
DEC/CNCTR Test Failure Data:
(error message)
```

Refer to the section *DEC Error Messages* for a list of the error messages and their meaning.

You can use the **CF** command to select the port to be tested (whether AUI or TP). The following example uses the **CF** command to select port 1 (the TP port), skipping port 0 (the AUI port).

Example:

```
PPC1-Diag>CF DEC
DEC Configuration Data:
Port Select =00000000 ? 1
```

ERREN - PERREN/SERREN Bit Toggle

Command Input

```
PPC1-Diag>DEC ERREN
```

Description

This test toggles the PERREN and SERREN (Address and Data Parity Error status) bits in the command register found in the PCI header address space to verify that this register functions properly. Each bit is toggled (written) and then read to verify that they are indeed toggled.

Response/Messages

After the command has been issued, the following line is printed:

```
DEC ERREN:PERREN and SERREN bit toggle:...Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
DEC ERREN:PERREN and SERREN bit toggle:...Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
DEC ERREN:PERREN and SERREN bit toggle:...Running ---> FAILED

DEC/ERREN Test Failure Data:
(error message)
```

Refer to the section *DEC Error Messages* for a list of the error messages and their meaning.

ILR - Interrupt Line Register Access

Command Input

```
PPC1-Diag>DEC ILR
```

Description

This test sends all possible byte patterns (0x00 - 0xFF) to the Interrupt Line register in the PCI register space. It verifies that the register can be read and written for all possible bit combinations. It checks that the byte read is the same as the byte previously written to verify that the register holds data correctly.

Response/Messages

After the command has been issued, the following line is printed:

```
DEC ILR:Interrupt Line Register Access:..Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
DEC ILR:Interrupt Line Register Access:. Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
DEC ILR:Interrupt Line Register Access:..Running ---> FAILED

DEC/ILR Test Failure Data:
(error message)
```

Refer to the section *DEC Error Messages* for a list of the error messages and their meaning.

IOR - I/O Resource Register Access

Command Input

```
PPC1-Diag>dec ior
```

Description

This test reads all the I/O resource registers (pointed to by the PCI Base Address register) and all the indexed registers read indirectly through the RAP index register, and CSR/BCR data registers. This test verifies that the registers can be accessed and that the data paths to the device are functioning.

Response/Messages

After the command has been issued, the following line is printed:

```
DEC IOR: I/O Resource Register Access:....Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
DEC IOR: I/O Resource Register Access:....Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
DEC IOR: I/O Resource Register Access:....Running ---> FAILED

DEC/IOR Test Failure Data:
(error message)
```

Refer to the section *DEC Error Messages* for a list of the error messages and their meaning.

REGA - PCI Header Register Access

Command Input

```
PPC1-Diag>DEC REGA
```

Description

This test performs a read test on the Vendor ID and the Device ID registers in the DEC PCI header space and verifies that they contain the correct values. This test verifies that the registers can be accessed and that the data paths to the device are functioning.

Response/Messages

After the command has been issued, the following line is printed:

```
DEC   REGA: PCI Register Access..... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
DEC   REGA: PCI Register Access..... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
DEC   REGA: PCI Register Access..... Running ---> FAILED

DEC/REGA Test Failure Data:
(error message)
```

Refer to the section *DEC Error Messages* for a list of the error messages and their meaning.

SPACK - Single Packet Send/Receive

Command Input

```
PPC1-Diag>DEC SPACK
```

Description

This test verifies that the DEC Ethernet Controller can successfully send and receive an Ethernet packet, using interrupts in internal loopback mode.

Response/Messages

After the command has been issued, the following line is printed:

```
DEC   SPACK: Single Packet Xmit/Recv:..... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
DEC   SPACK: Single Packet Xmit/Recv:..... Running --->PASSED
```

If any part of the test fails, then the display appears as follows:

```
DEC   SPACK: Single Packet Xmit/Recv:..... Running --->FAILED

DEC/SPACK Test Failure Data:
(error message)
```

Refer to the section *DEC Error Messages* for a list of the error messages and their meaning.

XREGA - Extended PCI Register Access

Command Input

```
PPC1-Diag>DEC XREGA
```

Description

This test performs a read test on all of the registers in the DEC PCI header space and verifies that they contain the correct values. This test verifies that the registers can be accessed and that the data paths to the device are functioning.

Response/Messages

After the command has been issued, the following line is printed:

```
DEC   XREGA:Extended PCI register Access:.Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
DEC   XREGA:Extended PCI register Access..Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
DEC   XREGA:Extended PCI register Access:.Running ---> FAILED

DEC/XREGA Test Failure Data:
(error message)
```

Refer to the section *DEC Error Messages* for a list of the error messages and their meaning.

DEC Error Messages

The **DEC** test group error messages generally take the following form:

```
DEC CLOAD: Continuous Load:.......... Running ---> FAILED

DEC/CLOAD Test Failure Data:

Ethernet packet data mismatch:
Iter: nnnn Element: nnn Value sent: xxxx Value returned: xxxx
```

The first line of the test failure data identifies what type of failure occurred. The following line provides additional information about the failure.

Table 3-4. DEC Error Messages

Error Message	Symptom or Cause
`Initialization Error: Init.Block Address mismatch`	Init. Block address given to controller was not properly stored after initialization.
`Initialization Error: Transmit Ring Size mismatch`	Controller did not properly detect Transmit Descriptor Ring size after initialization.
`Initialization Error: Receive Ring Size mismatch`	Controller did not properly detect Receive Descriptor Ring size after initialization.
`Initialization Error: Logical Ethernet Address Filter, byte N mismatch`	Controller not properly storing *N*th byte of the Logical Ethernet filter address after initialization.
`Initialization Error: Physical Ethernet Address, byte N mismatch`	Controller not properly storing *N*th byte of the Physical Ethernet Address after initialization.
`Initialization Error: Mode Register mismatch`	Controller not properly storing the operating mode register after initialization.

Table 3-4. DEC Error Messages (Continued)

Error Message	Symptom or Cause
`Initialization Error: Receive Descriptor Ring address mismatch`	Controller not properly storing the address of the Receive Descriptor ring after initialization.
`Initialization Error: Transmit Descriptor Ring address mismatch`	Controller not properly storing the address of the Transmit Descriptor ring after initialization.
`Not enough diagnostics memory to accommodate DEC buffers.`	There was not enough diagnostics memory space available for use by the Initialization block, Descriptor Rings, and buffers.
`PCI` *`XXX`* `register contains invalid data. Detected Value:` *`NNN`* `Should Be:` *`NNN`*	The PCI Header Register, as listed, contains a bad value, other than a fixed, predetermined constant. May indicate a bad device, or faulty interface to it.
`Interrupt Line register mismatch error Value sent:` *`NNN`* `Value returned:` *`NNN`*	The value read is not the same as what was written, indicating that there is a problem storing data in the PCI Header register space.
`Unable to set(reset) the PERREN(SERREN) bit in the PCI command register.`	Inability to toggle bits in the PCI command register, which may indicate faulty interface to the PCI header registers.
`Unsolicited Exception: Exception Time IP` *`NNN`* `Vector` *`NNN`*	An interrupt occurred where it was not supposed to, usually because of a bus error, indicating a basic system problem interfacing to the controller.

Table 3-4. DEC Error Messages (Continued)

Error Message	Symptom or Cause
`Transmit of Ethernet Packet Failed: Lost Carrier (LCAR)`	Carrier Signal got lost during a packet transmit, in AUI or TP (twisted pair) mode.
`Transmit of Ethernet Packet Failed: Late Collision (LCOL)`	A Collision occurred after the slot time of the channel had elapsed.
`Transmit of Ethernet Packet Failed: Too many Retries (RTRY)`	Transmit failed too many times, indicating a transmission problem over the network.
`Transmit of Ethernet Packet Failed: Buffer Error (BUFF)`	ENP flag not found at the end of a transmitted frame, and the next packet is not owned by controller.
`Transmit of Ethernet Packet Failed: Underflow error (UFLO)`	Transmitter truncated a message, due to data unavailability.
`Transmit of Ethernet Packet Failed: Excessive Deferral (EXDEF)`	IEEE/ANSI 802.3 defined excessive deferral of transmitted packet.
`Receive of Ethernet Packet Failed: Invalid Checksum (CRC)`	Packet Checksum vs. Data is invalid, indicating bad transmission of packet.
`Receive of Ethernet Packet Failed: Framing Error (FRAM)`	Some bits were missing on an incoming byte in a frame.
`Receive of Ethernet Packet Failed: Overflow condition (OFLO)`	FIFO unable to store incoming packet, usually because packet is too large to fit in buffer.
`Receive of Ethernet Packet Failed: Buffer error (BUFF)`	Buffer is not available to receive incoming frame, usually because ownership has not been given back to controller.

Table 3-4. DEC Error Messages (Continued)

Error Message	Symptom or Cause
`Time out waiting for Interrupt`	An expected interrupt, either from Initialization, Transmit or Receive was never received, indicating some other problem has occurred.
`Memory Error interrupt encountered (MERR)`	Interrupt that occurs when the controller cannot access the memory bus.
`Time Out interrupt encountered (BABL)`	Interrupt indicating that transmitter has taken too long to transmit a frame.
`Collision Error interrupt encountered (CERR)`	Interrupt indicating that the AUI port collision inputs failed to activate in a timely manner after a frame was transmitted.
`Missed Frame interrupt encountered (MISS)`	Interrupt indicating that the receiver missed an incoming frame because there was no place to put it (no buffers owned by controller).
`Jabber Error interrupt encountered (JAB)`	Interrupt indicating that the twisted pair transmission limit has been exceeded.
`Collision Counter Overflow interrupt encountered (RCVCCO)`	Too many collisions have occurred.

Table 3-4. DEC Error Messages (Continued)

Error Message	Symptom or Cause
`Receive interrupt occurred, but no data available.`	Controller interrupted indicating that data has been received, but the incoming byte count does not reflect this.
`Received packet is the wrong size.`	Size of packet is not the same size as it was when it was sent.
`Requested packet size of %d illegal Must be in range` *`NN`* `to` *`NNN`*	Size of packet to send is out of boundaries, as defined by standard Ethernet packet sizings.
`Ethernet packet data mismatch Iter:` *`NNN`* `Element:` *`NN`* `Value sent:` *`XXXX`* `Value returned:` *`XXXX`*	Data in packet received does not equal data in the packet that was sent.

ISABRDGE - PCI/ISA Bridge Tests

This section describes the individual Isabrdge (PCI/ISA Bridge) tests.

Entering **ISABRDGE** without parameters causes all **ISABRDGE** tests to execute in the order shown in the following table.

To run an individual test, add that test name to the **ISABRDGE** command.

The individual tests are described in alphabetical order on the following pages.

Table 3-5. ISABRDGE Test Group

Name	Description
REG	Register
IRQ	Interrupt

IRQ - Interrupt

Command Input

```
PPC1-Diag>ISABRDGE IRQ
```

Description

This test verifies that the ISABRDGE can generate interrupts.

Response/Messages

After the command has been issued, the following line is printed:

```
ISABRDGE IRQ: Interrupt..................... Running --->
```

If all parts of the test are completed correctly, then the test passes.

```
ISABRDGE IRQ: Interrupt..................... Running ---> PASSED
```

If any failures occur, the following is displayed (more descriptive text then follows):

```
ISABRDGE IRQ: Interrupt..................... Running ---> FAILED
```

If the test fails because an interrupt request from the ISABRDGE is pending, after masking the ISABRDGE interrupt in the IEN register, the following is displayed:

```
ISABRDGE/IRQ Test Failure Data:
Unexpected ISABRDGE IRQ pending
Address =________, Expected =________, Actual =________
```

This test makes use of the ISABRDGE counters, to generate the test interrupt. If after running the counters to “terminal count”, an interrupt has not been requested by the ISABRDGE, the following message is displayed:

```
ISABRDGE/IRQ Test Failure Data:
ISABRDGE IRQ not pending in IST register
Address =________, Expected =________, Actual =________
```

REG - Register

Command Input:

```
PPC1-Diag>ISABRDGE REG
```

Description

This test verifies that the ISABRDGE registers can be written and read. Data patterns verify that every read/write bit can be modified.

Response/Messages

After the command has been issued, the following line is printed:

```
ISABRDGE REG: Register..................... Running --->
```

If all parts of the test are completed correctly, then the test passes.

```
ISABRDGE REG: Register..................... Running ---> PASSED
```

If any failures occur, the following is displayed (more descriptive text then follows):

```
ISABRDGE REG: Register..................... Running ---> FAILED
```

If the test fails because the pattern written does not match the data read back from the ISABRDGE register, the following is printed:

```
ISABRDIGE/LNK Test Failure Data:
Register xxx Miscompare Error:Address =____,Expected =_,Actual =_
```

KBD8730x - Keyboard Controller Tests

These sections describe the individual PC8730x Keyboard Controller, Mouse, and Keyboard Device tests.

Entering **KBD8730x** without parameters causes all **KBD8730x** tests to run in the order shown in the table below, except as noted.

To run an individual test, add that test name to the **KBD8730x** command.

The individual tests are described in alphabetical order on the following pages.

Table 3-6. KBD8730x Test Group

Name	Description
KCCONF	Keyboard Controller Confidence
KBCONF	Keyboard Device Confidence/Extended
MSCONF	Mouse Device Confidence/Extended
Executed only when specified:	
KCEXT	Keyboard/Mouse Controller Extended Test
KBFAT	Keyboard Test
MSFAT	Mouse Test

There are no configuration parameters for these tests. The KBFAT and MSFAT tests assume that there is a keyboard and a mouse present, otherwise they will fail. The other tests need not have any keyboard or mouse connected in order to operate successfully.

KBCONF - Keyboard Device Confidence/Extended

Command Input

```
PPC1-Diag>KBD8730x KBCONF
```

Description

This test performs an interface test of the keyboard controller to ensure correct operation of the interface to the keyboard device.

Response/Messages

After the command has been issued, the following line is printed:

```
KBD8730x kbconf:Keyboard Device Confidence/Extended:Running ->
```

If all parts of the test are completed correctly, then the test passes:

```
KBD8730x kbconf:Keyboard Device Confidence/Extended:Running -> PASSED
```

If any part of the test fails, then the display appears as follows:

```
KBD8730x kbconf:Keyboard Device Confidence/Extended:Running -> FAILED

KBD8730x/kbconf Test Failure Data:
(error message)
```

Refer to the section *KBD8730x Error Messages* for a list of the error messages and their meaning.

KBFAT - Keyboard Test

Command Input

```
PPC1-Diag>kbd8730x kbfat
```

Description

This test performs all the tests found in the keyboard device confidence/extended (**kbconf**) tests, issues an echo test to the keyboard device, issues a reset command to the keyboard device, and reads the keyboard device ID from the keyboard to ensure that the keyboard is plugged in and functioning correctly. These tests can only function with a keyboard device present.

Response/Messages

After the command has been issued, the following line is printed:

```
KBD8730x KBFAT: Keyboard Test:.............. Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
KBD8730x KBFAT: Keyboard Test:.............. Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
KBD8730x KBFAT: Keyboard Test:.............. Running ---> FAILED

KBD8730x/KBFAT Test Failure Data:
(error message)
```

Refer to the section *KBD8730x Error Messages* for a list of the error messages and their meaning.

KCCONF - Keyboard Controller Confidence/Extended

Command Input

```
PPC1-Diag>KBD8730x KCCONF
```

Description

This test writes a command byte and reads it back from the PC8730x keyboard controller to place it in correct operation mode, and test that the registers can be accessed and that the data paths to the device are functioning. It then issues a keyboard controller self-command to invoke the internal diagnostics that are performed in the keyboard controller itself.

Response/Messages

After the command has been issued, the following line is printed:

```
KBD8730x KCCONF:Keyboard Controller Confidence:.Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
KBD8730x KCCONF:Keyboard Controller Confidence:.Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
KBD8730x KCCONF:Keyboard Controller Confidence:.Running ---> FAILED

KBD8730x/KCCONF Test Failure Data:
(error message)
```

Refer to the section *KBD8730x Error Messages* for a list of the error messages and their meaning.

KCEXT - Keyboard/Mouse Controller Extended Test

Command Input

```
PPC1-Diag>KBD8730x KCEXT
```

Description

This test performs all the functions in the keyboard controller confidence tests (**kcconf**), tests the keyboard controller RAM locations by writing all possible byte values (0x00-0xff) to all possible RAM locations, and tests the Password functionality of the controller.

Response/Messages

After the command has been issued, the following line is printed:

```
KBD8730x KCEXT:Keyboard Controller Extended/Test:.Running ->
```

If all parts of the test are completed correctly, then the test passes:

```
KBD8730x KCEXT:Keyboard Controller Extended/Test:.Running -> PASSED
```

If any part of the test fails, then the display appears as follows:

```
KBD8730x KCEXT:Keyboard Controller Extended/Test:.Running -> FAILED

KBD8730x/KCEXT Test Failure Data:
(error message)
```

Refer to the section *KBD8730x Error Messages* for a list of the error messages and their meaning.

MSCONF - Mouse Device Confidence/Extended

Command Input

```
PPC1-Diag>kbd8730x msconf
```

Description

This test performs an interface test of the keyboard controller to ensure correct operation of the interface to the mouse device.

Response/Messages

After the command has been issued, the following line is printed:

```
KBD8730x MSCONF:Mouse Device Confidence/Extended:.Running -->
```

If all parts of the test are completed correctly, then the test passes:

```
KBD8730x MSCONF:Mouse Device Confidence/Extended:.Running --> PASSED
```

If any part of the test fails, then the display appears as follows:

```
KBD8730x MSCONF:Mouse Device Confidence/Extended:.Running --> FAILED

KBD8730x/MSCONF Test Failure Data:
(error message)
```

Refer to the section *KBD8730x Error Messages* for a list of the error messages and their meaning.

MSFAT - Mouse Test

Command Input

```
PPC1-Diag>KBD8730x MSFAT
```

Description

This test performs all the tests found in the mouse device confidence/extended (**msconf**) tests, reads the Mouse Device Type byte from the mouse device, and reads the status bytes from the mouse device to ensure that the mouse is plugged in and functioning correctly. These tests can only function with a mouse device present.

Response/Messages

After the command has been issued, the following line is printed:

```
KBD8730x MSFAT: Mouse Test:.................. Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
KBD8730x MSFAT: Mouse Test:.................. Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
KBD8730x MSFAT: Mouse Test:.................. Running ---> FAILED

KBD8730x/MSFAT Test Failure Data:
(error message)
```

Refer to the section *KBD8730x Error Messages* for a list of the error messages and their meaning.

KBD8730x Error Messages

The KBD8730x test group error messages generally take the following form:

```
KBD8730x KBFAT: Keyboard Test:.............. Running ---> FAILED

KBD8730x/KBFAT Test Failure Data:
Failure during command: XX
Keyboard Controller timed out waiting for Output Buffer Full
```

The first line of the test failure data identifies what type of failure occurred. The following line provides additional information about the failure.

Table 3-7. KBD8730x Error Messages

Error Message	Symptom or Cause

`Failure during command: XX`
`(Writing byte: XX to controller port 60h)`
`Keyboard Controller timed out waiting for Input Buffer Empty`
	Keyboard controller never became ready to receive command or data byte. Possible problem with keyboard controller embedded firmware.

`Failure during Keyboard command: XX` `Time out: possible device not present`	Failure of keyboard controller or keyboard device to send back a byte as a result of a command given to the keyboard device. Indicates problem with keyboard controller embedded firmware or the keyboard device itself.
`Failure during Mouse command: XX` `Time out: possible device not present`	Failure of keyboard controller or mouse device to send back a byte as a result of a command given to the mouse device. Indicates problem with keyboard controller embedded firmware or the mouse device itself.

Table 3-7. KBD8730x Error Messages (Continued)

Error Message	Symptom or Cause
`Failure during command: XX` `Keyboard Controller timed out waiting for Output Buffer Full`	Failure of keyboard controller to send back a byte as a result of a command given to the keyboard controller itself. Indicates a possible problem with the keyboard controller embedded firmware or hardware.
`Controller Command mismatch error` `Value written: XX Value read: XX`	Command byte read from keyboard controller does not equal what was sent. Indicates possible problem with bus interface to keyboard controller, or its embedded firmware.
`Keyboard Controller Failed Self Test (0xAA)`	Keyboard controller self-test command returned result that indicates a failure. May indicate a problem with the embedded firmware.
`Controller RAM mismatch error` `Value written: XX Value read: XX`	The value read from one of the keyboard controller RAM locations does not equal to what was written, indicating a possible problem with the controller, or it's embedded firmware.
`Invalid result from Password Test command`	The password test command failed, returning an invalid result, indicating that there may be a problem with the embedded firmware.

Table 3-7. KBD8730x Error Messages (Continued)

Error Message	Symptom or Cause
`Password Test failed, password should exist, but doesn't`	A password that was given to the keyboard controller was not stored properly, indicating a possible problem with the embedded firmware.
`Password Test failed, password should not exist, but does`	There was a failure in clearing out the password from the keyboard controller, indicating a possible problem with the embedded firmware.
`Unsolicited Exception:` `Exception Time IP` *`NNNN`* `Vector` *`NNNN`*	An unexpected interrupt occurred, indicating a possible bus error, or faulty interface to the keyboard controller.
`Keyboard Interface test failed` `Clock(Data) line is stuck high(low).`	There is a problem with the interface to the keyboard device, or the keyboard device itself. One of the data or clock lines is not operating correctly.
`Keyboard Interface test failed` `Invalid test result from controller`	There was a complete failure of the interface test to the keyboard device. May be a problem with the embedded firmware itself.
`Keyboard Echo test failed:Invalid result code=` *`XX`*	The echo test to the keyboard failed, indicating that the keyboard may not be present or working properly.

Table 3-7. KBD8730x Error Messages (Continued)

Error Message	Symptom or Cause
`Keyboard Internal Diagnostic test failure: Check keyboard` `Invalid result code (%x) from Keyboard Internal Diagnostic test`	The keyboard device internal diagnostics test failed, indicating a problem with the keyboard device itself.
`Invalid ACK from Keyboard Read ID test.Getting` *`XX`*	Keyboard device failed to send an Acknowledge byte, indicating that it may be not present or working correctly.
`Keyboard Read ID failed: First(Second) byte,` *`XX`*`, should be` *`XX`*`.`	Keyboard sending the wrong ID byte(s) back, indicating wrong device type being used, or a problem with the device.
`Mouse Interface test failed` `Clock(Data) line is stuck high(low).`	There is a problem with the interface to the mouse device, or the mouse device itself. One of the data or clock lines is not operating correctly.
`Mouse Interface test failed` `Invalid test result from controller`	Indicates a complete failure of the interface test to the mouse device. May be a problem with the embedded firmware itself
`Mouse Read ID failed, returning` *`XX`*`, should be` *`XX`*`.`	Mouse is sending the wrong ID byte(s) back, indicating wrong device type being used, or a problem with the device.

L2CACHE - Level 2 Cache Tests

This section describes the individual Level 2 (L2) Cache tests.

Entering **L2CACHE** without parameters causes all **L2CACHE** tests to run in the order shown in the table below, except as noted.

To run an individual test, add that test name to the **L2CACHE** command.

The individual tests are described in alphabetical order on the following pages.

Table 3-8. L2CACHE Test Group

Name	Description
WBFL	Write Back w/Flush
WBINV	Write Back w/Invalidate
WRTHRU	WriteThru
DISUPD	Disable Updating
ENUPD	Enable Updating
PATTERN	WriteThru Pattern
Executed only when specified:	
SIZE	Verify Cache Size

DISUPD - Disable Updating

Command Input

```
PPC1-Diag>l2cache disupd
```

Description

This test performs a write/read test on the L2 Cache. The main objective of this test is to exercise the L2 Cache with Cache Updating disabled. The test flow is as follows:

Turn on the cache with updating and WriteBack. Write an incrementing pattern to cache original region. Verify the incrementing pattern. Turn off cache updating. Write a decrementing pattern to displacing memory region. Turn off the cache. Write decrementing pattern to original memory region. Verify the decrementing pattern. Turn on the cache with WriteBack. Verify the decrementing pattern in the cache.

Response/Messages

After the command has been issued, the following line is printed:

```
L2CACHE DISUPD: L2-Cache Disable Updating... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
L2CACHE DISUPD: L2-Cache Disable Updating... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
L2CACHE DISUPD: L2-Cache Disable Updating... Running ---> FAILED

L2CACHE/DISUPD Test Failure Data:
(error message)
```

Refer to the section *L2CACHE Error Messages* for a list of the error messages and their meaning.

ENUPD - Enable Updating

Command Input

```
PPC1-Diag>l2cache enupd
```

Description

This test performs a write/read test on the L2 Cache. The main objective of this test is to exercise the L2 Cache with Cache Updating enabled. The test flow is as follows:

Turn on the cache with WriteBack. Write an incrementing pattern to cache original region. Verify the incrementing pattern. Turn off cache. Write a decrementing pattern to original memory region. Turn on the cache with WriteBack and enable updating. Write decrementing pattern to displacing memory region. Verify the incrementing pattern from the original region.

Response/Messages

After the command has been issued, the following line is printed:

```
L2CACHE ENUPD: L2-Cache Enable Updating... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
L2CACHE ENUPD: L2-Cache Enable Updating... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
L2CACHE ENUPD: L2-Cache Enable Updating... Running ---> FAILED

L2CACHE/ENUPD Test Failure Data:
(error message)
```

Refer to the section *L2CACHE Error Messages* for a list of the error messages and their meaning.

PATTERN - WriteThru Pattern

Command Input

```
PPC1-Diag>l2cache pattern
```

Description

This test performs a write/read test on the L2 Cache. The main objective of this test is to exercise the L2 Cache WriteThru control, using multiple bit patterns. The test flow is as follows:

Turn on the cache with WriteThru. Write an incrementing pattern to memory and the cache. Verify pattern is in the cache. Turn off the cache. Verify the pattern is outside of cache.

Response/Messages

After the command has been issued, the following line is printed:

```
L2CACHE PATTERN: L2-Cache WriteThru Pattern... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
L2CACHE PATTERN: L2-Cache WriteThru Pattern... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
L2CACHE PATTERN: L2-Cache WriteThru Pattern... Running ---> FAILED

L2CACHE/PATTERN Test Failure Data:
(error message)
```

Refer to the section *L2CACHE Error Messages* for a list of the error messages and their meaning.

SIZE - Verify Cache Size

Command Input

```
PPC1-Diag>l2cache size
```

Description

The main objective of this test is to verify the size of the L2 Cache, as indicated by the CPU Type Register. An error is reported if the size is incorrect.

Response/Messages

After the command has been issued, the following line is printed:

```
SIZE: Verify Cache Size..............Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
SIZE: Verify Cache Size..............Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
SIZE: Verify Cache Size..............Running ---> FAILED

L2CACHE/SIZE Test Failure Data:
(error message)
```

Refer to the section *L2CACHE Error Messages* for a list of the error messages and their meaning.

WBFL - Write Back w/Flush

Command Input

```
PPC1-Diag>l2cache wbfl
```


Description

This test performs a write/read test on the L2 Cache. This test verifies that the device can be both accessed and that the L2 Cache Flush control works. The test flow is as follows:

Turn off the cache. Write an incrementing pattern to memory and verify that the pattern is in memory. Turn on the cache with WriteBack. Write a decrementing pattern to the cache. Turn off the cache. Verify that the incrementing pattern is still in memory. Turn on the cache with WriteBack. Flush the cache, which should flush the cache contents to memory. Turn off the cache. Verify that the decrementing pattern is in memory.

Response/Messages

After the command has been issued, the following line is printed:

```
L2CACHE WBFL: L2-Cache WriteBack w/ Flush... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
L2CACHE WBFL: L2-Cache WriteBack w/ Flush... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
L2CACHE WBFL: L2-Cache WriteBack w/ Flush... Running ---> FAILED

L2CACHE/WBFL Test Failure Data:
(error message)
```

Refer to the section *L2CACHE Error Messages* for a list of the error messages and their meaning.

WBINV - Write Back w/Invalidate

Command Input

```
PPC1-Diag>l2cache wbinv
```

Description

This test performs a write/read test on the L2 Cache. This test verifies that the device can be both accessed and that the L2 Cache Invalidate control is working. The test flow is as follows:

Turn off the cache. Write an incrementing pattern to memory. Turn on the cache with WriteBack. Write a decrementing pattern to cache while invalidating the cache. Flush the cache, which should have no effect. Verify that the incrementing pattern is still in memory.

Response/Messages

After the command has been issued, the following line is printed:

```
L2CACHE WBINV: L2-Cache WriteBack w/Invalidate... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
L2CACHE WBINV: L2-Cache WriteBack w/Invalidate... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
L2CACHE WBINV: L2-Cache WriteBack w/Invalidate... Running ---> FAILED

L2CACHE/WBINV Test Failure Data:
(error message)
```

Refer to the section *L2CACHE Error Messages* for a list of the error messages and their meaning.

WRTHRU - WriteThru

Command Input

```
PPC1-Diag>l2cache wrthru
```


Description

This test performs a write/read test on the L2 Cache. This test verifies that the device can be both accessed and that the L2 Cache WriteThru control is working. The test flow is as follows:

Turn on the cache with WriteThru. Write an incrementing pattern to memory and the cache. Verify the incrementing pattern. Turn off the cache. Verify that the incrementing pattern is in memory. Write decrementing pattern to memory. Verify the decrementing pattern. Turn on the cache with WriteThru, and verify the incrementing pattern in cache.

Response/Messages

After the command has been issued, the following line is printed:

```
L2CACHE WRTHRU: L2-Cache WriteThru..... Running --->
```

If all parts of the test are completed correctly, then the test passes.

```
L2CACHE WRTHRU: L2-Cache WriteThru..... Running ---> PASSED
```

If all parts of the test are not completed correctly, then the test does not pass:

```
L2CACHE WRTHRU: L2-Cache WriteThru..... Running ---> FAILED

L2CACHE/WRTHRU Test Failure Data:
(error message)
```

Refer to the section *L2CACHE Error Messages* for a list of the error messages and their meaning.

L2CACHE Error Messages

The L2 Cache test group error messages generally take the following form:

```
L2CACHE DISUPD: L2-Cache Disable Updating... Running ---> FAILED

L2CACHE/DISUPD Test Failure Data:
Data Miscompare Failure:
Address =00040000, Expected =00000000, Actual =FFFFFFFF
```

The first line of the failure identifies what type of failure occurred. The following line provides additional information about the failure.

Table 3-9. L2CACHE Error Messages

Error Message	Symptom or Cause
`f_l2cache_init: internal error: unexpected cmd=0xYY`	Init function called with something other than INIT, DONE, or SETUP.
`L2-Cache Size Miscompare Error: Address = %08X, Expected = %s, Actual = %s`	Cache Size does not match expected.
`Data Miscompare Failure:` `Address =00040000, Expected =00000000, Actual =FFFFFFFF`	Data write does not match data read.

NCR - 53C8xx SCSI I/O Processor Tests

These sections describe the individual NCR 53C8xx (SCSI I/O Processor) tests.

Entering **NCR** without parameters causes all **NCR** tests in the order shown in the table below.

To run an individual test, add that test name to the **NCR** command.

The individual tests are described in alphabetical order on the following pages.

Table 3-10. NCR Test Group

Name	Description
PCI	PCI Access
ACC1	Device Access
ACC2	Register Access
SFIFO	SCSI FIFO
DFIFO	DMA FIFO
SCRIPTS	SCRIPTs Processor
IRQ	Interrupts

The error message displays following the explanation of an **NCR** test pertain to the test being discussed.

ACC1 - Device Access

Command Input

```
PPC1-Diag>NCR ACC1
```

Description

This procedure tests the basic ability to access the NCR 53C8xx device.

1. All device registers are accessed (read) on 8-bit and 32-bit boundaries. (No attempt is made to verify the contents of the registers.)
2. The device data lines are checked by successive writes and reads to the SCRATCH register, by walking a 1 bit through a field of zeros and walking a 0 bit through a field of ones.

If no errors are detected, the NCR device is reset; otherwise the device is left in the test state.

Response/Messages

After the command has been issued, the following line is printed:

```
NCR  ACC1: Device Access..................... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
NCR  ACC1: Device Access..................... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
NCR  ACC1: Device Access..................... Running ---> FAILED

NCR/ACC1 Test Failure Data:
(error message)
```

Here *(error message)* is one of the following:

```
SCRATCH Register is not initially cleared

Device Access Error:
Address =________, Expected =________, Actual =________

Device Access Error:
```

```
Bus Error Information:
                Address ________
                Data ________
                Access Size __
                Access Type _
                Address Space Code _
                Vector Number ___


Unsolicited Exception:
                Program Counter ________
                Vector Number ___
                Status Register ____
                Interrupt Level _
```

Notes 1. All error message data is displayed as hexadecimal values.

2. The Unsolicited Exception information is only displayed if the exception was not a Bus Error.

3. Access Size is displayed in bytes.

4. Access Type is: 0 (write), or 1 (read).

ACC2 - Register Access

Command Input

```
PPC1-Diag>ncr acc2
```

Description

This procedure tests the basic ability to access the NCR 53C8xx registers, by checking the state of the registers from a software reset condition and checking their read/write ability. Status registers are checked for initial clear condition after a software reset. Writable registers are written and read with a walking 1 through a field of zeros.

If no errors are detected, the NCR device is reset; otherwise the device is left in the test state.

Response/Messages

After the command has been issued, the following line is printed:

```
NCR  ACC2: Register Access.................. Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
NCR  ACC2: Register Access.................. Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
NCR  ACC2: Register Access.................. Running ---> FAILED

NCR/ACC2 Test Failure Data:
(error message)
```

Here *(error message)* is one of the following:

```
ISTAT Register is not initially cleared

SSTAT0 Register is not initially cleared

SSTAT1 Register is not initially cleared

SSTAT2 Register is not initially cleared

SIEN Register Error:
Address =________, Expected =__, Actual =__
```

```
SDID Register Error:
Address =________, Expected =__, Actual =__

SODL Register Error:
Address =________, Expected =__, Actual =__

SXFER Register Error:
Address =________, Expected =__, Actual =__

SCID Register Error:
Address =________, Expected =__, Actual =__

DSA Register Error:
Address =________, Expected =________, Actual =________

TEMP Register Error:
Address =________, Expected =________, Actual =________

DMA Next Address Error:
Address =________, Expected =________, Actual =________

Register Access Error:

Bus Error Information:
                Address ________
                Data ________
                Access Size __
                Access Type _
                Address Space Code _
                Vector Number ___

Unsolicited Exception:
                Program Counter ________
                Vector Number ___
                Status Register ____
                Interrupt Level _
```

Notes 1. All error message data is displayed as hexadecimal values.

2. The Unsolicited Exception information is only displayed if the exception was not a Bus Error.

3. Access Size is displayed in bytes.

4. Access Type is: 0 (write), or 1 (read).

DFIFO - DMA FIFO

Command Input

```
PPC1-Diag>NCR DFIFO
```

Description

This procedure tests the basic ability to write data into the DMA FIFO and retrieve it in the same order as written. The DMA FIFO is checked for an empty condition following a software reset, then the FBL2 bit is set and verified. The FIFO is then filled with 16 bytes of data in the four byte lanes verifying the byte lane full or empty with each write. Next the FIFO is read verifying the data and the byte lane full or empty with each read.

If no errors are detected, the NCR device is reset; otherwise the device is left in the test state.

Response/Messages

After the command has been issued, the following line is printed:

```
NCR  DFIFO: DMA FIFO..................... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
NCR  DFIFO: DMA FIFO..................... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
NCR  DFIFO: DMA FIFO..................... Running ---> FAILED

NCR/DFIFO Test Failure Data:
(error message)
```

Here *(error message)* is one of the following:

```
DMA FIFO is not initially empty

DMA FIFO Byte Control not enabled
Address =________, Expected =__, Actual =__

DMA FIFO Byte Control Error:
Address =________, Expected =__, Actual =__
```

```
DMA FIFO Empty/Full Error:
Address =________, Expected =__, Actual =__

DMA FIFO Parity Error:
Address =________, Expected =__, Actual =__ DMA FIFO Byte Lane _

DMA FIFO Error:
Address =________, Expected =__, Actual =__ DMA FIFO Byte Lane _
```

IRQ - Interrupts

Command Input

```
PPC1-Diag>NCR IRQ
```

Description

This test verifies that interrupts can be generated and received and that the appropriate status is set.

Response/Messages

After the command has been issued, the following line is printed:

```
NCR  IRQ: NCR 53C8xx Interrupts.............. Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
NCR  IRQ: NCR 53C8xx Interrupts.............. Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
NCR  IRQ: NCR 53C8xx Interrupts.............. Running ---> FAILED

NCR/IRQ Test Failure Data:
 (error message)
```

Here *(error message)* is one of the following:

```
Test Initialization Error:
Not Enough Memory, Need =________, Actual =________

Test Initialization Error:
Memory Move Byte Count to Large, Max =00ffffff, Requested =________

Test Initialization Error:
Test Memory Base Address Not 32 Bit Aligned =________

SCSI Status Zero "SGE" bit not set
Address =________, Expected =__, Actual =__

Interrupt Status "SIP" bit not set
Address =________, Expected =__, Actual =__

SCSI Status Zero "SGE" bit will not clear
Address =________, Expected =__, Actual =__
```

```
Interrupt Status “SIP” bit will not clear
Address =________, Expected =__, Actual =__

Interrupt Control Reg. not initially clear
Address =________, Expected =__, Actual =__

SCSI Interrupt Enable “SGE” bit not set
Address =________, Expected =__, Actual =__

Interrupt Control “IEN” bit not set
Address =________, Expected =__, Actual =__

Interrupt Status bit did not set
Status: Expected =__, Actual =__
Vector: Expected =__, Actual =__
State : IRQ Level =_, VBR =__

Interrupt Control “INT” bit will not clear
Address =________, Expected =__, Actual =__

SCSI Interrupt Enable Reg. will not mask interrupts
Address =________, Expected =__, Actual =__

Incorrect Vector type
Status: Expected =__, Actual =__
Vector: Expected =__, Actual =__
State : IRQ Level =_, VBR =__

SCSI Interrupt
Status: Expected =__, Actual =__
DMA Interrupt
Status: Expected =__, Actual =__

Unexpected Vector taken
Status: Expected =__, Actual =__
Vector: Expected =__, Actual =__
State : IRQ Level =_, VBR =__

Interrupt did not occur
Status: Expected =__, Actual =__
Vector: Expected =__, Actual =__
State : IRQ Level =_, VBR =__

Interrupt Status bit did not set
Status: Expected =__, Actual =__
Vector: Expected =__, Actual =__
State : IRQ Level =_, VBR =__

Interrupt Control “INT” bit will not clear
Address =________, Expected =__, Actual =__
```

```
Bus Error Information:
                Address ________
                Data ________
                Access Size __
                Access Type _
                Address Space Code _
                Vector Number ___

Unsolicited Exception:
                Program Counter ________
                Vector Number ___
                Status Register ____
                Interrupt Level _
```

PCI - PCI Access

Command Input

```
PPC1-Diag>ncr pci
```

Description

This procedure tests the basic ability to access the PCI Configuration register address space for the NCR 53C8xx device. It performs a read of the address space and copies it into local memory and checks for bus errors and other catastrophic errors during this process.

If no errors are detected, the NCR device is reset; otherwise the device is left in the test state.

Response/Messages

After the command has been issued, the following line is printed:

```
NCR  PCI: PCI Access..................... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
NCR  PCI: PCI Access..................... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
NCR  PCI: PCI Access..................... Running ---> FAILED

NCR/PCI Test Failure Data:
(error message)
```

Here *(error message)* is one of the following:

```
Unsolicited Exception:
Exception Time IP xxxxxxx
Vector nnnn
```

If it happens that the exception is a bus error, more information follows:

```
Data-Access/Machine-Check Information:
Address xxxxxxxx
Data dddddddd
Access Size nnnn
Access Type xxxx
Address Space Code xxxx
bus error vector xxxxxxxx
```

Notes

1. All error message data is displayed as hexadecimal values.
2. Access Size is displayed in bytes.
3. Access Type is: 0 (write), or 1 (read).

SCRIPTS - SCRIPTs Processor

Command Input

```
PPC1-Diag>NCR SCRIPTS
```

Description

This test initializes the test structures and makes use of the diagnostic registers for test, as follows:

- Verifies that the following registers are initially clear:

SIEN	SCSI Interrupt Enable
DIEN	DMA Interrupt Enable
SSTAT0	SCSI Status Zero
DSTAT	DMA Status
ISTAT	Interrupt Status
SFBR	SCSI First Byte Received

- Sets SCSI outputs in high impedance state, disables interrupts using the "MIEN", and sets NCR device for Single Step Mode.
- Loads the address of a simple "INTERRUPT instruction" SCRIPT into the DMA SCRIPTs Pointer register. The SCRIPTs processor is started by hitting the "STD" bit in the DMA Control Register.

  Single Step is checked by verifying that ONLY the first instruction executed and that the correct status bits are set. Single Step Mode is then turned off and the SCRIPTs processor started again. The "INTERRUPT instruction" should then be executed and a check for the correct status bits set is made.
- Loads the address of the "JUMP instruction" SCRIPT into the DMA SCRIPTs Pointer register, and the SCRIPTs processor is automatically started. JUMP "if TRUE" (Compare = True, Compare = False) conditions are checked, then JUMP "if

FALSE" (Compare = True, Compare = False) conditions are checked.

- Builds the "Memory Move instruction" SCRIPT in a script buffer to allow the "Source Address", "Destination Address", and "Byte Count" to be changed by use of the "config" command. If a parameter is changed, the only check for validity is the "Byte Count" during test structures initialization.

  The "Memory Move" SCRIPT copies the specified number of bytes from the source address to the destination address.

Response/Messages

After the command has been issued, the following line is printed:

```
NCR  SCRIPTS: NCR 53C8xx SCRIPTs Processor... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
NCR  SCRIPTS: NCR 53C8xx SCRIPTs Processor... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
NCR  SCRIPTS: NCR 53C8xx SCRIPTs Processor... Running ---> FAILED

NCR/SCRIPTS Test Failure Data:
(error message)
```

Here *(error message)* is one of the following:

```
Test Initialization Error:
Not Enough Memory, Need =________, Actual =________

Test Initialization Error:
Memory Move Byte Count to Large, Max =00ffffff, Requested =________

Test Initialization Error:
Test Memory Base Address Not 32 Bit Aligned =________

SCSI Interrupt Enable Reg. not initially clear
Address =________, Expected =__, Actual =__

DMA Interrupt Enable Reg. not initially clear
Address =________, Expected =__, Actual =__
```

```
SCSI Status Zero Reg. not initially clear
Address =________, Expected =__, Actual =__

DMA Status Reg. not initially clear
Address =________, Expected =__, Actual =__

Interrupt Status Reg. not initially clear
Address =________, Expected =__, Actual =__

SCSI First Byte Received Reg. not initially clear
Address =________, Expected =__, Actual =__

SCSI First Byte Received Reg. not set
Address =________, Expected =__, Actual =__

DMA Status "SSI" bit not set
Address =________, Expected =__, Actual =__

Interrupt Status "DIP" bit not set
Address =________, Expected =__, Actual =__

SCSI Status Zero Reg. set during single step
Address =________, Expected =__, Actual =__

Test Timeout during: INTERRUPT SCRIPTs Test
Address =________, Expected =__, Actual =__

"SIR" not detected during: INTERRUPT SCRIPTs Test
Address =________, Expected =__, Actual =__

Test Timeout during: JUMP SCRIPTs Test
Address =________, Expected =__, Actual =__

"SIR" not detected during: JUMP SCRIPTs Test
Address =________, Expected =__, Actual =__

Jump if "True", and Compare = True; Jump not taken

Jump if "True", and Compare = False; Jump taken

Jump if "False", and Compare = True; Jump taken

Jump if "True", and Compare = False; Jump not taken

Test Timeout during: Memory Move SCRIPTs Test
Address =________, Expected =__, Actual =__

"SIR" not detected during: Memory Move SCRIPTs Test
Address =________, Expected =__, Actual =__
```

SFIFO - SCSI FIFO

Command Input

```
PPC1-Diag>ncr sfifo
```

Description

This procedure tests the basic ability to write data into the SCSI FIFO and retrieve it in the same order as written. The SCSI FIFO is checked for an empty condition following a software reset, then the SFWR bit is set and verified. The FIFO is then filled with 8 bytes of data verifying the byte count with each write. Next the SFWR bit is cleared and the FIFO read, verifying the byte count with each read.

If no errors are detected, the NCR device is reset; otherwise the device is left in the test state.

Response/Messages

After the command has been issued, the following line is printed:

```
NCR  SFIFO: SCSI FIFO..................... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
NCR  SFIFO: SCSI FIFO..................... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
NCR  SFIFO: SCSI FIFO..................... Running ---> FAILED

NCR/SFIFO Test Failure Data:
 (error message)
```

Here *(error message)* is one of the following:

```
SCSI FIFO is not initially empty

SCSI FIFO writes not enabled

SCSI FIFO Count Error:
Address =________, Expected =__, Actual =__

SCSI FIFO Error:
Address =________, Expected =__, Actual =__
```

PAR8730x - Parallel Port Test

This section describes the PC8730x parallel port test. This test is performed using only one processor.

You may enter **PAR8730x** with or without specifying the **REG** test. **REG** is the only test in the **PAR8730x** group.

The **REG** test is described on the following page.

Table 3-11. PAR8730x Test Group

Name	Description
REG	Register

REG - Register

Command Input:

```
PPC1-Diag>PAR8730x REG
```

Description

This test verifies that all of the PC8730x registers can be written and read. Data patterns verify that every read/write bit can be modified.

Response/Messages

After the command has been issued, the following line is printed:

```
PAR8730x REG:PC8730x Parallel Port's Register/Data..Running -->
```

If all parts of the test are completed correctly, then the test passes:

```
PAR8730x REG:PC8730x Parallel Port's Register/Data..Running --> PASSED
```

If any failures occur, the following is displayed (more descriptive text then follows):

```
PAR8730x REG:PC8730x Parallel Port's Register/Data..Running --> FAILED
```

If the test fails because the pattern written doesn't match the data read back from the PAR8730x register, the following is printed:

```
PAR8730x/REG Test Failure Data:
Register xxx Miscompare Error:Address =____,Expected =_,Actual =_
```

UART - Serial Input/Output Tests

These sections describe the individual UART tests.

Entering **UART** without parameters causes all **UART** tests to run in the order shown in the table below, except as noted.

To run an individual test, add that test name to the **UART** command.

The individual tests are described in alphabetical order on the following pages.

Table 3-12. UART Test Group

Name	Description
REGA	Register Access
IRQ	Interrupt Request
BAUD	Baud Rate tests
LPBK	Internal loopback
Executed only when specified:	
LPBKE	External Loopback

You can use the **CF** command to select the ports to be tested. This example uses the **CF** command to select port 0, skipping 1.

Example:

```
PPC1-Diag>CF UART
External-Loopback Port Mask =00000002? 01
```

(Bit 0 selects port 0, Bit 1 selects port 1, etc. -- see note below.)

The next parameter is the port selection mask. This mask is used during testing to identify which ports are to be tested. The default is to test every port except the console port. The External-Loopback Port Mask is used for the **LPBKE** test suite.

BAUD - Baud Rates

Command Input

```
PPC1-Diag>UART BAUD
```

Description

This test transmits 18 characters at various baud rates. The data is received and compared. If any protocol errors are created or the data is not correct when received, the test failed.

The bauds tested are:

300	9600
1200	19200
2400	38400

Response/Messages

After the command has been issued, the following line is printed:

```
UART   BAUD: Baud Rates.................. Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
UART   BAUD: Baud Rates.................. Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
UART   BAUD: Baud Rates.................. Running ---> FAILED

UART/BAUD Test Failure Data:
(error message)
```

Refer to the section *UART Error Messages* for a list of the error messages and their meaning.

IRQ - Interrupt Request

Command Input

```
PPC1-Diag>UART IRQ
```

Description

This test verifies that the UARTs can generate interrupts to the local processor. This is done using the transmitter empty interrupt from the UART under test.

Response/Messages

After the command has been issued, the following line is printed:

```
UART   IRQ: Interrupt Request..... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
UART   IRQ: Interrupt Request..... Running --->PASSED
```

If any part of the test fails, then the display appears as follows:

```
UART   IRQ: Interrupt Request..... Running --->FAILED

UART/IRQ Test Failure Data:
(error message)
```

Refer to the section *UART Error Messages* for a list of the error messages and their meaning.

LPBK - Internal Loopback

Command Input

```
PPC1-Diag>UART lpbk
```

Description

This test transmits 18 characters at 9600 baud. The data is received and compared. If any protocol errors are created or the data is not correct when received, the test failed.

Response/Messages

After the command has been issued, the following line is printed:

```
UART   LPBK: Internal Loopback.......... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
UART   LPBK: Internal Loopback.......... Running --->PASSED
```

If any part of the test fails, then the display appears as follows:

```
UART   LPBK: Internal Loopback.......... Running --->FAILED

UART/LPBK Test Failure Data:
(error message)
```

Refer to the section *UART Error Messages* for a list of the error messages and their meaning.

LPBKE - External Loopback

Command Input

```
PPC1-Diag>UART lpbke
```

Description

This test transmits 18 characters at 9600 baud. The data is received and compared. If any protocol errors are created or the data is not correct when received, the test failed. This test also verifies that modem control lines may be asserted and deasserted and that these signals are received back by the UART.

This test *does* require an external loopback connector to be installed. For this test, the following connections need to be made in the loopback connector:

TxD connected to **RxD**

DTR connected to **DCD** and **DSR**

RTS connected to **CTS** and **RI**

Response/Messages

After the command has been issued, the following line is printed:

```
UART   LPBKE: External Loopback.......... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
UART   LPBKE: External Loopback.......... Running --->PASSED
```

If any part of the test fails, then the display appears as follows:

```
UART   LPBKE: External Loopback.......... Running --->FAILED

UART/LPBKE Test Failure Data:
(error message)
```

Refer to the section *UART Error Messages* for a list of the error messages and their meaning.

REGA - Device/Register Access

Command Input

```
PPC1-Diag>UART REGA
```

Description

This test performs a read test on all registers in the PC16550 UARTs. It also verifies that the UART scratch registers are readable and writable. This test verifies that the device can be both accessed and that the data paths to the device are functioning.

Response/Messages

After the command has been issued, the following line is printed:

```
UART   REGA: Register Access.............. Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
UART   REGA: Register Access.............. Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
UART   REGA: Register Access.............. Running ---> FAILED

UART/REGA Test Failure Data:
(error message)
```

Refer to the section *UART Error Messages* for a list of the error messages and their meaning.

UART Error Messages

The **UART** test group error messages generally take the following form:

```
UART  BAUD: Baud Rates.................. Running ---> FAILED

UART/BAUD Test Failure Data:
Data Miscompare Error:
Address =XXXXXXXX, Register Index =XX
Expected =XX, Actual =XX
```

The first line of the test failure data identifies what type of failure occurred. The following line provides additional information about the failure.

Table 3-13. UART Error Messages

Error Message	Symptom or Cause
`Unsolicited Exception:` `Vector XX`	An unexpected exception occurred.

`Data Miscompare Error:`
`Address =XXXXXXXX, Register Index =XX`
`Expected =XX, Actual =XX`
	Data write does not match data read.

`Transmit buffer failed to empty: channel %d`	Transmitter buffer remained full.
`Time out waiting for transmitter interrupt:channel XX`	During Interrupt testing, no interrupt was generated or received.
`Baud rate failure, expected %d took %d:channel XX`	Measured baud rate was not the same as that expected.
`Receiver line status interrupt occurred:channel XX` `<additional error information>`	Data transmission error occurred. Possible errors are: framing, parity, or data overrun.

Table 3-13. UART Error Messages (Continued)

Error Message	Symptom or Cause
`Unexpected modem status interrupt occurred:channel` *XX*	An unexpected change of modem signals was received during testing.
`Transmit/Receive character mismatch:channel XX`	Data transmitted does not match data received.
`Receiver Ready (Character Available) Time-Out` `PC16550 Base Address =`*XXXXXXXX*`, Channel =XX` `Baud Rate =`*XXXX*	The receiver has not received a character in the allotted time.
`DTR loopback to DSR and DCD Failed: Channel=`*XX*	When DTR was driven, DCD or DSR did not follow.
`RTS loopback to CTS and RI Failed: Channel=`*XX*	When RTS was driven, CTS or RI did not follow.

PCIBUS - Generic PCI/PMC Slot Tests

These sections describe the individual **PCIBUS** tests. These tests are available on all PowerPC boards.

Entering **PCIBUS** without parameters causes all **PCIBUS** tests to run in the order shown in the table below, except as noted.

To run an individual test, add that test name to the **PCIBUS** command.

The individual tests are described in alphabetical order on the following pages.

Table 3-14. PCIBUS Test Group

Name	Description
REG	Register Access

REG - PCI/PMC Slot Register Access

Command Input

```
PPC1-Diag>pcibus reg
```

Description

The purpose of this function is to test any available PCI or PMC slots on PowerPC based boards. The test loops through all possible slots for the current board. The test then checks to see if the slot is inhabited, if not, the test is not performed. If a device is present, its own Built-In-Self-Test is run, if possible, and the interrupt line register is written with a sixteen byte pattern. Each of these bytes written is verified, and finally the register is restored to its initial value.

Note The test will pass if all the conditions are met, **or** if the slot is not populated (some boards have multiple slots).

Response/Messages

After the command has been issued, the following line is printed:

```
PCIBUS REG: PCI/PMC Slot Register Access:... .Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
PCIBUS REG: PCI/PMC Slot Register Access:.....Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
PCIBUS REG: PCI/PMC Slot Register Access:.....Running ---> FAILED
(error message)
```

Refer to the section *PCIBUS Error Messages* for a list of the error messages and their meaning.

PCIBUS Error Messages

The **PCIBUS** test group error messages generally take the following form:

```
PCIBUS REG: PCI/PMC:.......... Running ---> FAILED

BIST failed to complete.
```

The first line of the test failure data identifies what type of failure occurred.

Table 3-15. PCIBUS Error Messages

Error Message	Symptom or Cause
`BIST failed to complete.`	The Built-In-Self-Test of the PCI or PMC device did not complete before timing out.
`Interrupt Line Register Write Error.`	The value read from the Interrupt Line Register does match what was written.

RAM - Local RAM Tests

These sections describe the individual Random Access Memory (RAM) tests.

Entering **RAM** without parameters causes all **RAM** tests to execute in the order shown in the table below.

To run an individual test, add that test name to the **RAM** command.

The individual tests are described in alphabetical order on the following pages.

Table 3-16. RAM Test Group

Name	Description
MARCH	March Pattern
QUIK	Quick Write/Read
ALTS	Alternating Ones/Zeros
PATS	Data Patterns
ADR	Memory Addressing
CODE	Code Execution/Copy
PERM	Permutations
RNDM	Random Data
BTOG	Bit Toggle
PED	Parity Error Detection
REF	Memory Refresh

ADR - Memory Addressing

Command Input

```
PPC1-Diag>RAM ADR
```

Description

This is the memory addressability test, the purpose of which is to verify addressing of memory in the range specified by the configuration parameters for the **RAM** test group. Addressing errors are sought by using a memory locations address as the data for that location. This test is coded to use only 32-bit data entities. The test proceeds as follows:

1. A Locations Address is written to its location (*n*).
2. The next location (*n*+4) is written with its address complemented.
3. The next location (*n*+8) is written with the most significant (MS) 16 bits and least significant (LS) 16 bits of its address swapped with each other.
4. Steps 1, 2, and 3 are repeated throughout the specified memory range.
5. The memory is read and verified for the correct data pattern(s) and any errors are reported.
6. The test is repeated using the same algorithm as above (steps 1 through 5) except that inverted data is used to insure that every data bit is written and verified at both “0” and “1”.

Response/Messages

After the command has been issued, the following line is printed:

```
RAM   ADR: Addressability.............. Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
RAM   ADR: Addressability.............. Running ---> PASSED
```

If the test fails, then the display appears as follows:

```
RAM   ADR: Addressability.............. Running ---> FAILED

RAM/ADR Test Failure Data:
Data Miscompare Error:
Address =________, Expected =________, Actual =________
```

ALTS - Alternating Ones/Zeros

Command Input

```
PPC1-Diag>RAM ALTS
```

Description

This test verifies addressing of memory in the range specified by the configuration parameters for the **RAM** test group. Addressing errors are sought by using a memory locations address as the data for that location. This test is coded to use only 32-bit data entities. The test proceeds as follows:

1. Location (*n*) is written with data of all bits 0.
2. The next location (*n*+4) is written with all bits 1.
3. Steps 1 and 2 are repeated throughout the specified memory range.
4. The memory is read and verified for the correct data pattern(s) and any errors are reported.

Response/Messages

After the command has been issued, the following line is printed:

```
RAM   ALTS: Alternating Ones/Zeroes.......... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
RAM   ALTS: Alternating Ones/Zeroes.......... Running ---> PASSED
```

If the test fails, then the display appears as follows:

```
RAM   ALTS: Alternating Ones/Zeroes.......... Running ---> FAILED

RAM/ALTS Test Failure Data:
Data Miscompare Error:
Address =________, Expected =________, Actual =________
```

BTOG - Bit Toggle

Command Input

```
PPC1-Diag>ram btog
```

Description

The memory range is specified by the RAM test directory configuration parameters. (Refer to *CF - Test Group Configuration Parameters Editor* in Chapter 2.) The RAM test directory configuration parameters also determine the value of the global random data seed used by this test. The global random data seed is incremented after it is used by this test. This test uses the following test data pattern generation algorithm:

1. Random data seed is copied into a work register.
2. Work register data is shifted right one bit position.
3. Random data seed is added to work register using unsigned arithmetic.
4. Data in the work register may or may not be complemented.
5. Data in the work register is written to current memory location.

If the RAM test directory configuration parameter for code cache enable equals "Y", the microprocessor code cache is enabled. This test is coded to operate using the 32-bit data size only. Each memory location in the specified memory range is written with the test data pattern. Each memory location in the specified memory range is then written with the test data pattern complemented before it is written. The memory under test is read back to verify that the complement test data is properly retained. Each memory location in the specified memory range is then written with the test data pattern. The memory under test is read back to verify that the test data is properly retained.

Response/Messages

After the command has been issued, the following line is printed:

```
RAM   BTOG: Bit Toggle..................... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
RAM   BTOG: Bit Toggle..................... Running ---> PASSED
```

If the test fails, then the display appears as follows:

```
RAM   BTOG: Bit Toggle..................... Running ---> FAILED

RAM/BTOG Test Failure Data:
Data Miscompare Error:
Address =________, Expected =________, Actual =________
```

CODE - Code Execution/Copy

Command Input

```
PPC1-Diag>RAM CODE
```

Description

Copy test code to memory and execute. The code in the memory under test copies itself to the next higher memory address and executes the new copy. This process is repeated until there is not enough memory, as specified by the configuration parameters, to perform another code copy and execution.

Response/Messages

After the command has been issued, the following line is printed:

```
RAM  CODE: Code Execution/Copy..............  Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
RAM  CODE: Code Execution/Copy..............  Running ---> PASSED
```

The test failure mode is typified by the nonjudicial of the `PASSED` message above after more than about 1 minute, which indicates that the MPU has irrecoverably crashed.

Hardware reset is required to recover from this error.

MARCH - March Pattern

Command Input

```
PPC1-Diag>ram march
```


Description

This is the memory march test, the purpose of which is to verify addressing of memory in the range specified by the configuration parameters for the **RAM** test group. Addressing errors are sought by writing a pattern and its complement to each location. This test is coded to use only 32-bit data entities. The test proceeds as follows:

1. Starting at the beginning test address and proceeding towards the ending address, each location is written with the starting pattern.
2. Starting at the beginning test address and proceeding towards the ending address, each location is verified to contain the starting pattern and is written with the complement of the starting pattern.
3. Starting at the ending test address and decreasing to the starting test address, each location is verified to contain the complement of the starting pattern and is then written with the starting pattern.

Response/Messages

After the command has been issued, the following line is printed:

```
RAM   MARCH: March Address.............. Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
RAM   MARCH: March Address.............. Running ---> PASSED
```

If the test fails, then the display appears as follows:

```
RAM   MARCH: March Address.............. Running ---> FAILED

RAM/MARCH Test Failure Data:
Data Miscompare Error:
Address =________, Expected =________, Actual =________
```

PATS - Data Patterns

Command Input

```
PPC1-Diag>RAM PATS
```

Description

If the test address range (test range) is less than 8 bytes, the test immediately returns pass status. The effective test range end address is reduced to the next lower 8-byte boundary if necessary. Memory in the test range is filled with all ones ($FFFFFFFF). For each location in the test range, the following patterns are used:

```
$00000000
$01010101
$03030303
$07070707
$0F0F0F0F
$1F1F1F1F
$3F3F3F3F
$7F7F7F7F
```

Each location in the test range is, individually, written with the current pattern and the 1's complement of the current pattern. Each write is read back and verified. This test is coded to use only 32-bit data entities.

Response/Messages

After the command has been issued, the following line is printed:

```
RAM   PATS: Patterns.................. Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
RAM   PATS: Patterns.................. Running ---> PASSED
```

If the test fails, then the display appears as follows:

```
RAM   PATS: Patterns.................. Running ---> FAILED

RAM/PATS Test Failure Data:
Data Miscompare Error:
Address =________, Expected =________, Actual =_________
```

PED - Local Parity Memory Error Detection

Command Input

```
PPC1-Diag>RAM PED
```

Description

The memory range and address increment is specified by the RAM test directory configuration parameters. (Refer to *CF - Test Group Configuration Parameters Editor* in Chapter 2.)

First, each memory location to be tested has the data portion verified by writing/verifying all zeros, and all ones. Each memory location to be tested is tested once with parity interrupt disabled, and once with parity interrupt enabled. Parity checking is enabled, and data is written and verified at the test location that causes the parity bit to toggle on and off (verifying that the parity bit of memory is good). Next, data with incorrect parity is written to the test location. The data is read, and if a parity error exception does occur, the fault address is compared to the test address. If the addresses are the same, the test passed and the test location is incremented until the end of the test range has been reached.

Response/Messages

After the command has been issued, the following line is printed:

```
RAM   PED: Local Parity Memory Detection..... Running --->
```

If the board under test does not support Parity error detection, the test is bypassed:

```
RAM   PED: Local Parity Memory Detection..... Running --> BYPASS
```

If all parts of the test are completed correctly, then the test passes:

```
RAM   PED: Local Parity Memory Detection..... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
RAM   PED: Local Parity Memory Detection..... Running ---> FAILED

RAM/PED Test Failure Data:
(error message)
```

Here *(error message)* is one of the following:

If a data verification error occurs:

```
Data Miscompare Error:
Address =________, Expected =________, Actual =________
```

If an unexpected exception, such as a parity error being detected as the parity bit was being toggled:

```
Unexpected Exception Error, Vector =________
Address Under Test =________
```

If no exception occurred when data with bad parity was read:

```
Parity Error Detection Exception Did Not Occur

Exception Vector =________
Address Under Test =________
```

If the exception address was different from that of the test location:

```
Fault Address Miscompare, Expected =________, Actual =________
```

PERM - Permutations

Command Input

```
PPC1-Diag>RAM PERM
```

Description

This command performs a test which verifies that the memory in the test range can accommodate 8-bit, 16-bit, and 32-bit writes and reads in any combination. The test range is the memory range specified by the **RAM** test group configuration parameters for starting and ending address. If the test address range (test range) is less than 16 bytes, the test immediately returns pass status. The effective test range end address is reduced to the next lower 16-byte boundary if necessary.

This test performs three data size test phases in the following order: 8, 16, and 32 bits. Each test phase writes a 16-byte data pattern (using its data size) to the first 16 bytes of every 256-byte block of memory in the test range. The 256-byte blocks of memory are aligned to the starting address configuration parameter for the **RAM** test group. The test phase then reads and verifies the 16-byte block using 8-bit, 16-bit, and 32-bit access modes.

Response/Messages

After the command has been issued, the following line is printed:

```
RAM   PERM: Permutations..................... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
RAM   PERM: Permutations..................... Running ---> PASSED
```

If the test fails, then the display appears as follows:

```
RAM   PERM: Permutations..................... Running ---> FAILED

RAM/PERM Test Failure Data:
Data Miscompare Error:
Address =________, Expected =________, Actual =________
```

QUIK - Quick Write/Read

Command Input

```
PPC1-Diag>ram quik
```

Description

Each pass of this test fills the test range with a data pattern by writing the current data pattern to each memory location from a local variable and reading it back into that same register. The local variable is verified to be unchanged only after the write pass through the test range. This test uses a first pass data pattern of 0, and $FFFFFFFF for the second pass. This test is coded to use only 32-bit data entities.

Response/Messages

After the command has been issued, the following line is printed:

```
RAM   QUIK: Quick Write/Read..... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
RAM   QUIK: Quick Write/Read..... Running ---> PASSED
```

If the test fails, then the display appears as follows:

```
RAM   QUIK: Quick Write/Read..... Running ---> FAILED

RAM/QUIK Test Failure Data:
Data Miscompare Error:
Expected =________, Actual =________
```

REF - Memory Refresh Testing

Command Input

```
PPC1-Diag>RAM REF
```

Description

The memory range and address increment is specified by the **RAM** test directory configuration parameters. (Refer to *CF - Test Group Configuration Parameters Editor* in Chapter 2.)

First, the real time clock is checked to see if it is functioning properly. Second, each memory location to be tested has the data portion verified by writing/verifying all zeros, and all ones. Next a data pattern is written to the test location. After all the data patterns are filled for all test locations, a refresh wait cycle is executed. After the wait cycle, the data is read, and if the previously entered data pattern does not match the data pattern read in, a failure occurs. If the data patterns match, then the test is passed.

Response/Messages

After the command has been issued, the following line is printed:

```
RAM   REF: Memory Refresh Test.............. Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
RAM   REF: Memory Refresh Test.............. Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
RAM   REF: Memory Refresh Test.............. Running ---> FAILED

RAM/REF Test Failure Data:
(error message)
```

Here *(error message)* is one of the following:

If the real time clock is not functioning properly, one of the following is printed:

```
RTC is stopped, invoke SET command.
```

Or:

```
RTC is in write mode, invoke SET command.
```

Or:

```
RTC is in read mode, invoke SET command.
```

If a data verification error occurs before the refresh wait cycle:

```
Immediate Data Miscompare Error:
Address =________, Expected =________, Actual =________
```

If a data verification error occurs following the refresh wait cycle:

```
Unrefreshed Data Miscompare Error:
Address =________, Expected =________, Actual =________
```

RNDM - Random Data

Command Input

```
PPC1-Diag>RAM RNDM
```

Description

The test block is the memory range specified by the **RAM** test group configuration parameters. The test proceeds as follows:

1. A random pattern is written throughout the test block.
2. The random pattern complemented is written throughout the test block.
3. The complemented pattern is verified.
4. The random pattern is rewritten throughout the test block.
5. The random pattern is verified.

This test is coded to use only 32-bit data entities. Each time this test is executed, the random seed in the **RAM** test group configuration parameters is post incremented by 1.

Response/Messages

After the command has been issued, the following line is printed:

```
RAM   RNDM: Random Data..................... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
RAM   RNDM: Random Data..................... Running ---> PASSED
```

If the test fails, then the display appears as follows:

```
RAM   RNDM: Random Data..................... Running ---> FAILED

RAM/RNDM Test Failure Data:
Data Miscompare Error:
Address =________, Expected =________, Actual =________
```

RTC - MK48Txx Timekeeping Tests

These tests check the BBRAM and clock portions of the MK48Txx Real Time Clock (RTC) chips.

Entering **RTC** without parameters causes all **RTC** tests to execute in the order shown in the table below, except as noted.

To run an individual test, add that test name to the **RTC** command.

The individual tests are described in alphabetical order on the following pages.

Table 3-17. RTC Test Group

Name	Description
RAM	Battery Backed-Up RAM
ADR	BBRAM Addressing
ALARM	Alarm Interrupt
Executed only when specified:	
CLK	Real Time Clock Function
WATCHDOG	Watchdog Time-Out Reset

ADR - MK48Txx BBRAM Addressing

Command Input

```
PPC1-Diag>RTC ADR
```

Description

This test is designed to assure proper addressability of the MK48Txx BBRAM. The algorithm used is to fill the BBRAM with data pattern “a”, a single address line of the MK48Txx is set to one, and pattern “b” is written to the resultant address. All other locations in the BBRAM are checked to ensure that they were not affected by this write. The “a” pattern is then restored to the resultant address. All address lines connected to the MK48Txx are tested in this manner.

Since this test overwrites all memory locations in the BBRAM, the BBRAM contents are saved in debugger system memory prior to writing the BBRAM. The RTC test group features a configuration parameter which overrides automatic restoration of the BBRAM contents. The default for this parameter is to restore BBRAM contents upon test completion.

Response/Messages

After the command has been issued, the following line is printed:

```
RTC  ADR: MK48Txx RAM Addressing..... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
RTC  ADR: MK48Txx RAM Addressing..... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
RTC  ADR: MK48Txx RAM Addressing..... Running ---> FAILED

RTC/ADR Test Failure Data:
(error message)
```

Here *(error message)* is one of the following:

If debugger system memory cannot be allocated for use as a save area for the BBRAM contents:

```
RAM allocate

memc.next=________ memc.size=________
```

If the BBRAM cannot be initialized with pattern “a”:

```
Data Verify Error: Address =________, Expected =__, Actual =__
Memory initialization error
```

If a pattern “b” write affects any BBRAM location other than the resultant address:

```
Data Verify Error: Address =________, Expected =__, Actual =__
Memory addressing error - wrote __ to ________
```

ALARM - Alarm Interrupt

Command Input

```
PPC1-Diag>rtc alarm
```

Description

This test sets the alarm of the Real Time Clock (RTC) MK48Txx to go off every second, and verifies that interrupt IRQ8 occurs and the AF (Alarm Flag) bit of the RTC is set.

Response/Messages

After the command has been issued, the following line is printed:

```
RTC  ALARM: MK48Txx Alarm Interrupt.......... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
RTC  ALARM: MK48Txx Alarm Interrupt.......... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
RTC  ALARM: MK48Txx Alarm Interrupt.......... Running ---> FAILED

RTC/ALARM Test Failure Data:
(error message)
```

Here *(error message)* is one of the following:

If the expected interrupt IRQ8 did not occur, *(error message)* is:

```
Interrupt failed to occur. Int Stat Reg : xx hex
```

where xx is the contents in hex of the Interrupt Status Register of the PCI-to_ISA Bridge.

If an interrupt other than IRQ8 occurred, *(error message)* is:

```
Spurious interrupt occurred instead of IRQ8.
Int Stat Reg : xx hex
```

If interrupt IRQ8 did occur but the AF (Alarm Flag) was not set, *(error message)* is:

```
AF (Alarm Flag) bit was not set
```

CLK - Real Time Clock Function

Command Input

```
PPC1-Diag>RTC CLK
```

Description

This test verifies the functionality of the Real Time Clock (RTC). This test does not check clock accuracy.

This test requires approximately nine seconds to run. At the conclusion of the test, nine seconds are added to the clock time to compensate for the test delay. Because the clock can only be set to the nearest second, this test may induce one second of error into the clock time.

Response/Messages

After the command has been issued, the following line is printed:

```
RTC  CLK: MK48Txx Real Time Clock..... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
RTC  CLK: MK48Txx Real Time Clock..... Running ---> PASSED
```

If the test fails, then the display appears as follows:

```
RTC  CLK: MK48Txx Real Time Clock..... Running ---> FAILED

RTC/CLK Test Failure Data:
(error message)
```

Here *(error message)* is one of the following:

If the check for low battery fails:

```
RTC low battery
```

The RTC time registers are configured for constant updating by the clock internal counters. The seconds register is read initially and then monitored (read) to verify that the seconds value changes. A predetermined number of reads are made of the seconds register.

If the predetermined number of reads are made before the seconds register changed, the following message is printed:

```
RTC not running
```

The RTC time registers are configured for reading. A predetermined number of MPU "do nothing" loops are executed. If the seconds register changes before the full count of MPU loops is executed, the following message is printed:

```
RTC did not freeze for reading
```

If the real-time clock registers fail the data pattern test:

```
Data Miscompare Error:
Address =________, Expected =________, Actual =________
```

The following message indicates a programming error and should never be seen by the diagnostics user:

```
WARNING -- Real Time Clock NOT compensated for test delay.
```

RAM - Battery Backed-Up RAM

Command Input

```
PPC1-Diag>rtc ram
```

Description

This test performs a data test on each BBRAM location of the MK48Txx "Timekeeper" RAM. RAM contents are unchanged upon completion of test, regardless of pass or fail test return status. This test is coded to test only byte data entities. The test proceeds as follows:

For each of the following patterns: $1, $3, $7, $f, $1f, $3f, $7f; for each valid byte of the "Timekeeper" RAM:

1. Write and verify the current data test pattern.
2. Write and verify the complement of the current data test pattern.

Response/Messages

After the command has been issued, the following line is printed:

```
RTC   RAM: MK48Txx Battery Backed Up RAM..... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
RTC   RAM: MK48Txx Battery Backed Up RAM..... Running ---> PASSED
```

If the test fails, then the display appears as follows:

```
RTC   RAM: MK48Txx Battery Backed Up RAM..... Running ---> FAILED

RTC/RAM Test Failure Data:
(error message)
```

Here *(error message)* is the following:

```
Data Miscompare Error:
Address =________, Expected =________, Actual =________
```

WATCHDOG - Watchdog Time-Out Reset

Command Input

```
PPC1-Diag>rtc watchdog
```

Description

This test sets the Real Time Clock's Watchdog Timer to time out in one second. If the Watchdog Timer is functional, the WDF (Watchdog Flag) bit will be set and a microprocessor reset will be generated.

Caution

If this test passes, the Real Time Clock will reset the board.

Response/Messages

After the command has been issued, the following line is printed:

```
RTC   WATCHDOG: MK48Txx Battery Backed Up RAM.. Running --->
```

If all parts of the test are completed correctly, then the test passes by resetting the board.

If the test fails, then the display appears as follows:

```
RTC   WATCHDOG: MK48Txx Battery Backed Up RAM.. Running ---> FAILED

RTC/WATCHDOG Test Failure Data:
(error message)
```

Here *(error message)* is the following:

If the Watchdog Timer failed to reset the microprocessor when a time-out condition occurred, *(error message)* is:

```
Processor reset failed to occur.
```

If the WDT bit failed to be set when a time-out condition occurred, *(error message)* is:

```
WDF (Watchdog Flag) bit was not set.
```

SCC - Serial Communication Controller (Z85230) Tests

These sections describe the individual Serial Communication Controller (SCC) tests. These tests are not available on the MVME230*x* boards.

Entering **SCC** without parameters causes all **SCC** tests to run in the order shown in the table below, except as noted.

To run an individual test, add that test name to the **SCC** command.

The individual tests are described in alphabetical order on the following pages.

Table 3-18. SCC Test Group

Name	Description
ACCESS	Device/Register Access
IRQ	Interrupt Request
Executed only when specified:	
BAUDS	Baud Rates
ELPBCK	External Loopback
ILPBCK	Internal Loopback
MDMC	Modem Control
DMA	Receive/Transmit DMA

Note These tests number the ports of the Z85230 starting with the first Z85230 channel 0 as being port A, the second channel 1 as being port B. For the Power PC family of boards there are only ports A and B.

You can use the **CF** command to select the ports to be tested. The following example uses the **CF** command to select port 1, skipping port 0.

Example:

```
PPC1-Diag>CF SCC
SCC Memory Space Base Address          =80000840?RETURN
Internal-Loopback/Baud-Rates Port Mask =00000003? 2
```

(Bit 0 selects port 0, Bit 1 selects port 1; see note below.)

```
External-Loopback/Modem-Control Port Mask=00000003?
```

The first parameter is the base address space for the Z85230 devices. This is preset for the PowerPC family of boards and should not be changed.

The next two parameters are the port selection masks. These masks are used during testing to identify which ports are to be tested. The default is to test every port. The Internal-Loopback/Baud-Rates Port Mask is used for the **BAUDS** and **ILPBCK** test suites. The External-Loopback/Modem-Control Port Mask is only used for the **ELPBCK** and **MDMC** test suites.

ACCESS - Device/Register Access

Command Input

```
PPC1-Diag>SCC ACCESS
```

Description

This test performs a write/read test on two registers in the Z85230. This test verifies that the device can be both accessed and that the data paths to the device are functioning.

Response/Messages

After the command has been issued, the following line is printed:

```
SCC  ACCESS: Device/Register Access...... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
SCC  ACCESS: Device/Register Access...... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
SCC  ACCESS: Device/Register Access...... Running ---> FAILED

SCC/ACCESS Test Failure Data:
(error message)
```

Refer to the section *SCC Error Messages* for a list of the error messages and their meaning.

BAUDS - Baud Rates

Command Input

```
PPC1-Diag>scc bauds
```

Description

This test transmits 256 characters at various baud rates. The data is received and compared. If any protocol errors are created or the data is not correct when received, the test failed.

The bauds tested are:

1200	9600
2400	19200
4800	38400

Note Because of the design of the Z85230, when internal loopback testing is performed, data is still transmitted out of the device on the TxD line. This may cause problems with terminals, modem, printers, and any other device attached.

Response/Messages

After the command has been issued, the following line is printed:

```
SCC  BAUDS: Baud Rates..................  Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
SCC  BAUDS: Baud Rates..................  Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
SCC  BAUDS: Baud Rates..................  Running ---> FAILED

SCC/BAUDS Test Failure Data:
(error message)
```

Refer to the section *SCC Error Messages* for a list of the error messages and their meaning.

DMA - Receive/Transmit DMA

Command Input

```
PPC1-Diag>SCC DMA
```

Description

This test will verify that the SCC can transmit and receive via internal loopback, a 256-byte block of data that consists of all numbers between 0x00 and 0xFF.

The test will be performed under DMA control. A match of the contents of the transmit and receive buffers will be verified. Due to the nature of DMA, use of the i82378 SIO IC is also necessary.

Note Because of the design of the Z85230, when DMA testing is performed, data is still transmitted out of the device on the TxD line. This may cause problems with terminals, modem, printers, and any other device attached.

Response/Messages

After the command has been issued, the following line is printed:

```
SCC  DMA: DMA Test..................... Running --->
```

If all parts of the test are completed correctly, then the test passes.

```
SCC  DMA: DMA Test..................... Running ---> PASSED
```

If all parts of the test are not completed correctly, then the test does not pass. The receiver buffer may not be filled with the data before terminal count. This results in either one or both controllers giving error messages:

```
SCC  DMA: DMA Test..................... Running ---> FAILED

SCC/DMA Test Failure Data:
(error message)
```

In the first case, the Serial Port 3 Receiver (Z85230 Port A Rx, I82378 DMA Controller 1 and Channel 0) has reached terminal count before receiving all the data. In the second case, the Serial Port 4 Receiver (Z85230 Port B Rx, I82378 DMA Controller 2 and Channel 5) has reached terminal count before receiving all the data.

If the receiver buffer is filled with data before terminal count, it may still be an incorrect match to the data transmitted. This results in an error:

```
SCC  DMA: DMA Test..................... Running ---> FAILED

SCC/DMA Test Failure Data:
(error message)
```

The Verify Counter used in this error message gives the amount of data transferred correctly. The values in the two buffers that did not match are shown also.

Refer to the section *SCC Error Messages* for a list of the error messages and their meaning.

ELPBCK - External Loopback

Command Input

```
PPC1-Diag>SCC ELPBCK
```

Description

This test transmits 256 characters at 38400 baud. The data is received and compared. If any protocol errors are created or the data is not correct when received, the test fails.

This test *does* require an external loopback connector to be installed. For this test, the following connections need to be made in the loopback connector:

TxD connected to **RxD**

Response/Messages

After the command has been issued, the following line is printed:

```
SCC ELPBCK: External Loopback..... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
SCC  ELPBCK: External Loopback..... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
SCC  ELPBCK: External Loopback..... Running ---> FAILED

SCC/ELPBCK Test Failure Data:
(error message)
```

Refer to the section *SCC Error Messages* for a list of the error messages and their meaning.

ILPBCK - Internal Loopback

Command Input

```
PPC1-Diag>SCC ILPBCK
```

Description

This test transmits 256 characters at 38400 baud. The data is received and compared. If any protocol errors are created or the data is not correct when received, the test failed.

Note Because of the design of the Z85230, when internal loopback testing is performed, data is still transmitted out of the device on the TxD line. This may cause problems with terminals, modem, printers, and any other device attached.

Response/Messages

After the command has been issued, the following line is printed:

```
SCC  ILPBCK: Internal Loopback..... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
SCC  ILPBCK: Internal Loopback..... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
SCC  ILPBCK: Internal Loopback..... Running ---> FAILED

SCC/ILPBCK Test Failure Data:
(error message)
```

Refer to the section *SCC Error Messages* for a list of the error messages and their meaning.

IRQ - Interrupt Request

Command Input

```
PPC1-Diag>scc irq
```

Description

This test verifies that the Z85230 can generate interrupts to the local processor. This is done using the baud rate zero counter interrupt from the Z85230.

Response/Messages

After the command has been issued, the following line is printed:

```
SCC  IRQ: Interrupt Request.............. Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
SCC  IRQ: Interrupt Request.............. Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
SCC  IRQ: Interrupt Request.............. Running ---> FAILED

SCC/IRQ Test Failure Data:
(error message)
```

Refer to the section *SCC Error Messages* for a list of the error messages and their meaning.

MDMC - Modem Control

Command Input

```
PPC1-Diag>SCC MDMC
```

Description

This test verifies that the Z85230 can negate / assert selected modem control lines and that the appropriate input control functions properly.

This test *does* require an external loopback connector to be installed. For this test the following connections need to be made in the loopback connector:

DTR connected to **DCD**

RTS connected to **CTS** and **DSR**

Note that DTR is asserted through the Z8536, not the Z85230, in this test.

Response/Messages

After the command has been issued, the following line is printed:

```
SCC  MDMC: Modem Control..... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
SCC  MDMC: Modem Control..... Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
SCC  MDMC: Modem Control..... Running ---> FAILED

SCC/MDMC Test Failure Data:
(error message)
```

Refer to the section *SCC Error Messages* for a list of the error messages and their meaning.

SCC Error Messages

The SCC test group error messages generally take the following form:

```
SCC   BAUDS: Baud Rates..................... Running ---> FAILED

SCC/BAUDS Test Failure Data:
Transmit/Receive Character Miscompare Error:
Expected =55, Actual =5F
SCC Base Address =80000840, Channel =01
Baud Rate =1200
```

The first line of the failure identifies what type of failure occurred. The following line provides additional information about the failure.

Table 3-19. SCC Error Messages

Error Message	Symptom or Cause
Exception, Vector *xx*	An unexpected exception occurred.
Data Miscompare Error: Address =*xxxxxxxx,* Register Index =*xx* Expected =*xx*, actual =*xx*	Data write does not match data read.
Exception Vector Serviced Error: Expected =*xxx,* Actual =*xxx* Interrupt Level =*x* SCC Base Address =*xxxxxxxx,* Channel =*xx*	Incorrect vector taken or provided during interrupt service.
Exception failed to occur, Vector Expected =*xxx* Interrupt Level =*X* SCC Base Address =*xxxxxxxx,* Channel =*xx*	During Interrupt testing, no interrupt was generated or received.
Interrupt Not (Stuck-At) Error: Vector =*xxx*, Interrupt Level =*x* SCC Base Address =*xxxxxxxx*, Channel =*xx*	A preexisting interrupt could not be cleared.
SCC Receiver Error: Status =*XXX* SCC Base Address =*xxxxxxxx,* Channel =*xx* Baud Rate =*xxxx* *<Additional error info>*	Data transmission error occurred. Possible error are: framing, parity, or data overrun

Table 3-19. SCC Error Messages (Continued)

Error Message	Symptom or Cause
SCC Receiver Error: Status =*xx* Break Sequence detected in the RXD stream SCC Base Address =*xxxxxxxx*, Channel =*xx* Baud Rate =*xxxx*	An unexpected break was received during testing.
Transmit/Receive Character Miscompare Error: Expected =*xx*, Actual =*xx* SCC Base Address =*xxxxxxxx,* Channel =*xx* Baud Rate =*xxxx*	Data transmitted does not match data received.
Transmitter Ready Time-Out SCC Base Address =*xxxxxxxx,* Channel =*xx* Baud Rate =*xxxx*	The selected ports transmitter never indicated ready to transmit.
Receiver Ready (Character Available) Time-Out SCC Base Address =*xxxxxxxx,* Channel =*xx* Baud Rate =*xxxx*	The receiver has not received a character in the allotted time.
DTR assertion failed to assert DCD SCC Base Address =*xxxxxxxx*, Channel =*xx*	When DTR was driven, DCD did not follow.
DTR negation failed to negate DCD SCC Base Address =*xxxxxxxx*, Channel =*xx*	
RTS assertion failed to assert CTS SCC Base Address =*xxxxxxxx*, Channel =*xx*	When RTS was driven, CTS did not follow.
RTS negation failed to negate CTS SCC Base Address =*xxxxxxxx*, Channel =*xx*	
SCC DMA #1 Error: Time-out before Terminal Count SCC Base Address =*xxxxxxxx*	The receiver (controller #1) did not receive all the data before TC.
SCC DMA #2 Error: Time-out before Terminal Count SCC Base Address =*xxxxxxxx*	The receiver (controller #2) did not receive all the data before TC.
SCC DMA Error: Data Miscompare Error SCC Base Address =*xxxxxxxx*, SCC Channel =*xx* Verify Counter =*xx* xmit buffer =*xxxxxxxx*, receive buffer =*xxxxxxxx*	Data transmitted does not match data received.

VGA543X - Video Diagnostics Tests

These sections describe the individual Video Graphics Array (VGA) tests. These tests are not available on the MVME230*x*, MVME260*x*, or MTX PowerPC boards.

Entering **VGA543X** without parameters causes all **VGA** tests to execute in the order shown in the table below.

To run an individual test, add that test name to the **VGA543X** command.

The individual tests are described in alphabetical order on the following pages.

Table 3-20. VGA543X Test Group

Name	Description
ATTR	Attribute Registers
CRTC	CRT Controller Registers
DSTATE	DAC State Register
EXTN	Extended Registers
GRPH	Graphics Controller
MISC	Miscellaneous Register
PAL	Color Palette
PCI	PCI Header Verification
PELM	Pixel Mask Register
SEQR	Sequencer Registers
VRAM	Video Memory
BLT	Bit Blitter

ATTR - Attribute Register

Command Input

```
PPC1-Diag>VGA543X ATTR
```

Description

This test verifies the correct operation of the VGA Attribute Registers. The test proceeds as follows:

1. Each Attribute Register is initialized with one of 256 possible values, with reserved bits being masked off to a value of zero.
2. The Attribute Register is read back to verify that the data that was written to the register in step 1 was written correctly.

Response/Messages

After the command has been issued, the following line is printed:

```
VGA543X  ATTR: Attribute Registers.........Running ->
```

If all parts of the test are completed correctly, then the test passes:

```
VGA543X  ATTR: Attribute Registers.........Running -> PASSED
```

If the test fails, then the display appears as follows:

```
VGA543X  ATTR: Attribute Registers.........Running -> FAILED

VGA543X/ATTR Test Failure Data:
Read Register: _________ Index register: ________
Value Read: ________ Expected: ________
```

BLT - Bit Blitter

Command Input

```
PPC1-Diag>vga543x blt
```

Description

This test verifies that the Bit Blitter of the Cirrus Logic CL-543X chip is functioning correctly by invoking a blitter operation to copy a block of data from system memory to video DRAM, then invoking a blitter operation to copy the block from one area in video DRAM to another and then finally a blitter operation to copy the block of data back into system memory. The contents of the original block of system memory are compared to that of the destination block. The test fails if the block which was blittered does not match the original block.

Response/Messages

After the command has been issued, the following line is printed:

```
VGA543x BLT: Cirrus vga543x bitblt.........Running ->
```

If all parts of the test are completed correctly, then the test passes:

```
VGA543x BLT: Cirrus vga543x bitblt.........Running -> PASSED
```

If any part of the test fails, then the display appears as follows:

```
VGA543x BLT: Cirrus vga543x bitblt .........Running -> FAILED

VGA543x/BLT Test Failure Data:
Memory compare error in bitblt test

byte ______,is__ should be__.
```

CRTC - CRT Controller Registers

Command Input

```
PPC1-Diag>VGA543X CRTC
```

Description

This test verifies the correct operation of the VGA CRT Controller Registers. The test proceeds as follows:

1. Each CRT Controller Register is initialized with one of 256 possible values, with reserved bits being masked off to a value of zero.
2. The CRT Controller Register is read back to verify that the data that was written to the register in step 1 was written correctly.

Response/Messages

After the command has been issued, the following line is printed:

```
VGA543X CRTC:CRT Controller Registers......Running -->
```

If all parts of the test are completed correctly, then the test passes:

```
VGA543X CRTC:CRT Controller Registers......Running --> PASSED
```

If the test fails, then the display appears as follows:

```
VGA543X CRTC:CRT Controller Registers......Running --> FAILED

VGA543X/CRTC Test Failure Data:
Data Register: ________ Index: _____
Value Read: ________ Expected: _______
```

DSTATE - DAC State Register

Command Input

```
PPC1-Diag>vga543x dstate
```

Description

Test the DAC State Register. This test verifies that the VGA controller changes when set to the various mode states.

Response/Messages

After the command has been issued, the following line is printed:

```
VGA543X  DSTATE: DAC State Registers........Running ->
```

If all parts of the test are completed correctly, then the test passes:

```
VGA543X  DSTATE: DAC State Registers........Running -> PASSED
```

If the test fails, then the display appears as follows:

```
VGA543X  DSTATE: DAC State Registers........Running -> FAILED

VGA543X/DSTATE Test Failure Data:
Unexpected state read from DAC State Reg
```

Depending upon which mode failed, then the display appears as follows:

```
Expected read mode (11B) Found: _____
```

Or:

```
Expected write mode (11B) Found: _____
```

EXTN - Extended Registers

Command Input

```
PPC1-Diag>VGA543X EXTN
```

Description

This test verifies that the Extended Sequencer, Graphics, CRT Controller, and Pel Mask Registers are correctly functioning. Each possible pattern for each of the registers is used with reserved bits being masked to a value of zero.

1. Each extended register is initialized with one of 256 possible values, with reserved bits being masked off to a value of zero.
2. The extended register is read back to verify that the data that was written to the register in step 1 was written correctly.

Response/Messages

After the command has been issued, the following line is printed:

```
VGA543X  EXTN: Extended Registers.........Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
VGA543X  EXTN: Extended Registers.........Running ---> PASSED
```

If the test fails, then the display appears as follows:

```
VGA543X  EXTN: Extended Registers.........Running ---> FAILED

VGA543X/EXTN Test Failure Data:
Read register: _____ Index Register: _____ loaded with _____
Value read: ________ Expected: ________
```

GRPH - Graphics Controller Registers

Command Input

```
PPC1-Diag>VGA543X GRPH
```

Description

This test verifies the correct operation of the VGA Graphics Controller Registers. The test proceeds as follows:

1. Each Graphics Controller Register is initialized with one of 256 possible values, with reserved bits being masked off to a value of zero.
2. The Graphics Controller Register is read back to verify that the data that was written to the register in step 1 was written correctly.

Response/Messages

After the command has been issued, the following line is printed:

```
VGA543X GRPH: Graphics Control Registers ...Running ->
```

If all parts of the test are completed correctly, then the test passes:

```
VGA543X GRPH: Graphics Control Registers....Running -> PASSED
```

If the test fails, then the display appears as follows:

```
VGA543X GRPH: Graphics Control Registers ...Running -> FAILED

VGA543X/GRPH Test Failure Data:
(error message)
```

If the error is in one of the index registers, then *(error message)* is:

```
Index register: _____
Value read: _____ Expected: _____
```

Otherwise, *(error message)* is:

```
Data register: _____
Value read: _____ Expected: _____
```

MISC - Miscellaneous Register

Command Input

```
PPC1-Diag>VGA543X MISC
```

Description

This test verifies the correct operation of the VGA Miscellaneous Control Register. The test proceeds as follows:

1. Each Graphics Controller Register is initialized with one of 256 possible values, with reserved bits being masked off to a value of zero.
2. The Graphics Controller Register is read back to verify that the data that was written to the register in step 1 was written correctly.

Response/Messages

After the command has been issued, the following line is printed:

```
VGA543X  MISC: Miscellaneous Registers....Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
VGA543X  MISC: Miscellaneous Registers....Running ---> PASSED
```

If the test fails, then the display appears as follows:

```
VGA543X  MISC: Miscellaneous Registers....Running ---> FAILED

VGA543X/MISC Test Failure Data:
Read Register: _____
Write Register: _____
Value read: ________ Expected: ________
```

PAL - Color Palette

Command Input

```
PPC1-Diag>VGA543X PAL
```

Description

This test verifies the correct operation of the 256 possible color palette entries. Each palette red, green, and blue entry is verified by checking for the setting of all bits to 1s and 0s.

Response/Messages

After the command has been issued, the following line is printed:

```
VGA543X  PAL: Palette Register.......... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
VGA543X  PAL: Palette Register.......... Running ---> PASSED
```

If the test fails, then the display appears as follows:

```
VGA543X  PAL: Palette Register.......... Running ---> FAILED

VGA543X/PAL Test Failure Data:
Palette index: _____
Value read: ________  red: ________ green: _____ blue: _____
```

PCI - PCI Header Verification

Command Input

```
PPC1-Diag>vga543x pci
```

Description

This is the PCI header verification test, the purpose of which is to verify that the system has either a Cirrus Logic 5430 or 5434 graphics controller. The test proceeds as follows:

1. Searches the PCI bus for the Cirrus Logic 5434 controller by looking at the chip identification register. If a Cirrus Logic 5434 is found, the test passes.
2. Searches the PCI bus for the Cirrus Logic 5430 controller by looking at the chip identification. If a Cirrus Logic 5430 is found, the test passes.

Response/Messages

After the command has been issued, the following line is printed:

```
VGA543X  PCI: Cirrus vga543x PCI Access....Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
VGA543X  PCI: Cirrus vga543x PCI Access ...Running ---> PASSED
```

If the test fails, then the display appears as follows:

```
VGA543X  PCI: Cirrus vga543x PCI Access ...Running ---> FAILED

VGA543X/PCI Test Failure Data:
PCI register test failure
```

PELM - Pixel Mask Register

Command Input

```
PPC1-Diag>VGA543X PELM
```

Description

This test verifies the correct operation of the VGA Pixel Mask Register. The test proceeds as follows:

1. The Pixel Mask Register is initialized with one of 256 possible values, with reserved bits being masked off to a value of zero.
2. The Pixel Mask Register is read back to verify that the data that was written to the register in step 1 was written correctly.

Response/Messages

After the command has been issued, the following line is printed:

```
VGA543X  PELM: Pixel Mask Register.........Running ->
```

If all parts of the test are completed correctly, then the test passes:

```
VGA543X  PELM: Pixel Mask Register.........Running -> PASSED
```

If any part of the test fails, then the display appears as follows:

```
VGA543X  PELM: Pixel Mask Register.........Running -> FAILED

VGA543X/PELM Test Failure Data:
Value read: ________  Expected: ________
```

SEQR - Sequencer Registers

Command Input

```
PPC1-Diag>VGA543X SEQR
```

Description

This test verifies the correct operation of the VGA Sequencer Controller Registers. The test proceeds as follows:

1. Each Sequencer Controller Register is initialized with one of 256 possible values, with reserved bits being masked off to a value of zero.
2. The Sequencer Controller Register is read back to verify that the data that was written to the register in step 1 was written correctly.

Response/Messages

After the command has been issued, the following line is printed:

```
VGA543X  SEQR: Sequencer Registers........Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
VGA543X  SEQR: Sequencer Registers........Running ---> PASSED
```

If the test fails, then the display appears as follows:

```
VGA543X  SEQR: Sequencer Registers........Running ---> FAILED

VGA543X/SEQR Test Failure Data:
(error message)

If the error is in one of the index registers, then (error message)
is:

Index register: _____
Value read: _____ Expected: _____
```

Otherwise, *(error message)* is:

```
Data register: _____
Value read: _____ Expected: _____
```

VRAM - Video Memory

Command Input

```
PPC1-Diag>VGA543X VRAM
```

Description

This test verifies the first 1 megabyte of video RAM. Each location is written as a 16-bit value with alternating 1s and 0s. The test restores each memory location as it is tested.

Response/Messages

After the command has been issued, the following line is printed:

```
VGA543X  VRAM: Cirrus vga543x VRAM Test...Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
VGA543X  VRAM: Cirrus vga543x VRAM.Test...Running ---> PASSED
```

If any part of the test fails, then the display appears as follows:

```
VGA543X  VRAM: Cirrus vga543x VRAM.Test...Running ---> FAILED

VGA543X/VRAM Test Failure Data:
Data Error: _____ Expected: _____ Actual: _____
Address: _____
```

VME2 - VME Interface ASIC Tests

This section lists the individual VMEchip2 tests, but does not describe them. These tests are available only on the MVME160*x* PowerPC boards. For all other PowerPC boards, these tests are bypassed.

Entering **VME2** without parameters causes all **VME2** tests to execute in the order shown in the table below.

To run an individual test, add that test name to the **VME2** command.

Table 3-21. VME2 Test Group

Name	Description
REGA	Register Access
REGB	Register Walking Bit
TMRA	Tick Timer 1 Increment
TMRB	Tick Timer 2 Increment
TMRC	Prescaler Clock Adjust
TMRD	Tick Timer 1 No Clear On Compare
TMRE	Tick Timer 2 No Clear On Compare
TMRF	Tick Timer 1 Clear On Compare
TMRG	Tick Timer 2 Clear On Compare
TMRH	Tick Timer 1 Overflow Counter
TMRI	Tick Timer 2 Overflow Counter
TMRJ	Watchdog Timer Counter
SWIA	Software Interrupts (Polled Mode)
SWIB	Software Interrupts (Processor Interrupt Mode)
SWIC	Software Interrupts Priority

Z8536 - Counter/Timer Tests

This section describes the individual Z8536 CIO counter/timer tests. These tests are not available on the MVME230*x* PowerPC boards.

Entering **Z8536** without parameters causes all **Z8536** tests to execute in the order shown in the following table.

To run an individual test, add that test name to the **Z8536** command.

The individual tests are described in alphabetical order on the following pages.

Table 3-22. Z8536 Test Group

Name	Description
CNT	Counter
LNK	Linked Counter
IRQ	Interrupt
REG	Register

CNT - Counter

Command Input

```
PPC1-Diag>z8536 cnt
```

Description

This test verifies the functionality of the counter in the Z8536 chip.

Response/Messages

After the command has been issued, the following line is printed:

```
Z8536  CNT: Counter..... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
Z8536  CNT: Counter..... Running ---> PASSED
```

If any failures occur, the following is displayed (more descriptive text then follows):

```
Z8536  CNT: Counter..... Running ---> FAILED

Z8536/CNT Test Failure Data:
(error message)
```

If the test fails because one of the counters does not generate an interrupt request in the correct time frame, the following message is displayed:

```
z8536 Timer A/B/C, No Terminal Count
Counter has not generated a Terminal Count IRQ in allotted time
```

IRQ - Interrupt

Command Input

```
PPC1-Diag>Z8536 IRQ
```

Description

This test verifies that the Z8536 can generate interrupts.

Response/Messages

After the command has been issued, the following line is printed:

```
Z8536 IRQ: Interrupt..................... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
Z8536 IRQ: Interrupt..................... Running ---> PASSED
```

If any failures occur, the following is displayed (more descriptive text then follows):

```
Z8536 IRQ: Interrupt..................... Running ---> FAILED

Z8536/CNT Test Failure Data:
(error message)
```

If the test fails because an interrupt request from the Z8536 is pending, after masking the Z8536 interrupt in the IEN register, the following is displayed:

```
Unexpected z8536 IRQ pending
Address =________, Expected =________, Actual =________
```

This test makes use of the Z8536 counter to generate the test interrupt. If after running the counters to “terminal count”, an interrupt has not been requested by the Z8536, the following message is displayed:

```
z8536 IRQ not pending in IST register
Address =________, Expected =________, Actual =________
```

LNK - Linked Counter

Command Input

```
PPC1-Diag>Z8536 LNK
```

Description

This test verifies the functionality of the timers in the Z8536. Counter 1 output is linked to counter 2 input. This test does not check timer accuracy.

Response/Messages

After the command has been issued, the following line is printed:

```
Z8536 LNK: Linked Counter.................. Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
Z8536 LNK: Linked Counter.................. Running ---> PASSED
```

If any failures occur, the following is displayed (more descriptive text then follows):

```
Z8536 LNK: Linked Counter.................. Running ---> FAILED

Z8536/LNK Test Failure Data:
(error message)
```

If the test fails because “terminal count” does not generate an interrupt request within a reasonable amount of time, the following message is displayed:

```
No Terminal Count occurred with in time limit
```

REG - Register

Command Input

```
PPC1-Diag>z8536 reg
```

Description

This test verifies that all of the Z8536 registers can be written and read. Data patterns verify that every read/write bit can be modified.

Response/Messages

After the command has been issued, the following line is printed:

```
Z8536 REG: Register..... Running --->
```

If all parts of the test are completed correctly, then the test passes:

```
Z8536 REG: Register..... Running ---> PASSED
```

If any failures occur, the following is displayed (more descriptive text then follows):

```
Z8536 REG: Register..... Running ---> FAILED

Z8536/REG Test Failure Data:
(error message)
```

If the test fails because the pattern written doesn't match the data read back from the Z8536 register, the following message is displayed:

```
Register xxx Miscompare Error:Address =____,Expected =_,Actual =_
```

Related Documentation A

Motorola Computer Group Documents

The publications listed below are on related products, and some may be referenced in this document. If not shipped with this product, manuals may be purchased by contacting your local Motorola sales office.

Please note that exact titles and part numbers of the documents are subject to change without notice.

Table A-1. Motorola Computer Group Documents

Document Title	Publication Number [1]
MVME2600 Series Single Board Computer Installation and Use[2]	V2600A/IH
MVME2600 Series Single Board Computer Programmer's Reference Guide[2]	V2600A/PG
MVME3600 Series Single Board Computer Installation and Use[3]	V3600A/IH
MVME4600 Series VME Processor Module Installation and Use [4]	V4600A/IH
MVME3600/4600 Series VME Processor Modules Programmer's Reference Guide[3,4]	V3600A/PG
MVME2300 VME Processor Module Installation and Use[5]	V2300A/IH
MVME2300 VME Processor Module Programmer's Reference Guide[5]	V2300A/PG
MTX Embedded ATX Motherboard Installation and Use[6]	MTXA/IH
MTX Embedded ATX Motherboard Programmer's Reference Guide[6]	MTXA/PG
PMCSpan PMC Adapter Carrier Module Installation and Use	PMCSPANA/IH
PPCBug Firmware Package User's Manual (Parts 1 and 2) [2, 3, 4, 5, 6]	PPCBUGA1/UM PPCBUGA2/UM
PPCBug Diagnostics Manual [2, 3, 4, 5,6]	PPCDIAA/UM
MVME712M Transition Module and P2 Adapter Board Installation and Use	VME712MA/IH
MVME761 Transition Module Installation and Use	VME761A/IH

Notes 1. Although not shown in the above list, each Motorola Computer Group manual publication number is suffixed with characters that represent the revision level of the document, such as "/*xx*2" (the second revision of a manual); a supplement bears the same number as the manual but has a suffix such as "/*xx*2A1" (the first supplement to the second revision of the manual).

2. Motorola documents marked with a **2** in the above list can be purchased as a set under part number **LK-2600A.** The content of this set is revised as needed and without any notice to the customer.

3. Motorola documents marked with a **3** in the above list can be purchased as a set under part number **LK-3600A**. The content of this set is revised as needed and without any notice to the customer.

4. Motorola documents marked with a **4** in the above list can be purchased as a set under part number **LK-4600**. The content of this set is revised as needed and without any notice to the customer.

5. Motorola documents marked with a **5** in the above list can be purchased as a set under part number **LK-2300**. The content of this set is revised as needed and without any notice to the customer.

6. Motorola documents marked with a **6** in the above list can be purchased as a set under part number **LK-MTX**. The content of this set is revised as needed and without any notice to the customer.

Manufacturers' Documents

For additional information, refer to the following table for manufacturers' data sheets or user's manuals. As an additional help, a source for the listed document is also provided. Please note that in many cases, the information is preliminary and the revision levels of the documents are subject to change without notice.

To further assist your development effort, Motorola has collected some of the non-Motorola documents in this list from the suppliers. This bundle can be ordered as part number **LK-PCIKIT2**.

Table A-2. Manufacturers' Documents

Document Title and Source	Publication Number
PowerPC 603™ RISC Microprocessor Technical Summary Literature Distribution Center for Motorola Telephone: (800) 441-2447 FAX: (602) 994-6430 or (303) 675-2150 E-mail: ldcformotorola@hibbertco.com	MPC603/D
PowerPC 603™ RISC Microprocessor User's Manual Literature Distribution Center for Motorola Telephone: (800) 441-2447 FAX: (602) 994-6430 or (303) 675-2150 E-mail: ldcformotorola@hibbertco.com OR IBM Microelectronics Mail Stop A25/862-1 PowerPC Marketing 1000 River Street Essex Junction, Vermont 05452-4299 Telephone: 1-800-PowerPC Telephone: 1-800-769-3772 FAX: 1-800-POWERfax FAX: 1-800-769-3732	MPC603UM/AD MPR603UMU-01

Table A-2. Manufacturers' Documents (Continued)

Document Title and Source	Publication Number
PowerPC 604™ RISC Microprocessor User's Manual Literature Distribution Center for Motorola Telephone: (800) 441-2447 FAX: (602) 994-6430 or (303) 675-2150 E-mail: ldcformotorola@hibbertco.com OR IBM Microelectronics Mail Stop A25/862-1 PowerPC Marketing 1000 River Street Essex Junction, Vermont 05452-4299 Telephone: 1-800-PowerPC Telephone: 1-800-769-3772 FAX: 1-800-POWERfax FAX: 1-800-769-3732	MPC604UM/AD MPR604UMU-01
PowerPC™ Microprocessor Family: The Programming Environments Literature Distribution Center for Motorola Telephone: (800) 441-2447 FAX: (602) 994-6430 or (303) 675-2150 E-mail: ldcformotorola@hibbertco.com OR IBM Microelectronics Mail Stop A25/862-1 PowerPC Marketing 1000 River Street Essex Junction, Vermont 05452-4299 Telephone: 1-800-PowerPC Telephone: 1-800-769-3772 FAX: 1-800-POWERfax FAX: 1-800-769-3732	MPCFPE/AD MPRPPCFPE-01
MPC2604GA Integrated Secondary Cache for PowerPC Microprocessors Data Sheets Literature Distribution Center for Motorola Telephone: (800) 441-2447 FAX: (602) 994-6430 or (303) 675-2150 E-mail: ldcformotorola@hibbertco.com	MPC2604GA

Table A-2. Manufacturers' Documents (Continued)

Document Title and Source	Publication Number
Alpine™ VGA Family - CL-GD543X/'4X Technical Reference Manual Fourth Edition Cirrus Logic, Inc. (or nearest Sales Office) 3100 West Warren Avenue Fremont, California 94538-6423 Telephone: (510) 623-8300 FAX: (510) 252-6020	385439
DECchip 21040 Ethernet LAN Controller for PCI Hardware Reference Manual Digital Equipment Corporation Maynard, Massachusetts DECchip Information Line Telephone (United States and Canada): 1-800-332-2717 TTY (United States only): 1-800-332-2515 Telephone (outside North America): +1-508-568-6868	EC-N0752-72
DECchip 21140 PCI Fast Ethernet LAN Controller Hardware Reference Manual Digital Equipment Corporation Maynard, Massachusetts DECchip Information Line Telephone (United States and Canada): 1-800-332-2717 TTY (United States only): 1-800-332-2515 Telephone (outside North America): +1-508-568-6868	EC-QC0CA-TE
PC87303VUL (Super I/O™ Sidewinder Lite) Floppy Disk Controller, Keyboard Controller, Real-Time Clock, Dual UARTs, IEEE 1284 Parallel Port, and IDE Interface National Semiconductor Corporation Customer Support Center (or nearest Sales Office) 2900 Semiconductor Drive P.O. Box 58090 Santa Clara, California 95052-8090 Telephone: 1-800-272-9959	PC87303VUL

Table A-2. Manufacturers' Documents (Continued)

Document Title and Source	Publication Number
PC87308VUL (Super I/O™ Enhanced Sidewinder Lite) Floppy Disk Controller, Keyboard Controller, Real-Time Clock, Dual UARTs, IEEE 1284 Parallel Port, and IDE Interface National Semiconductor Corporation Customer Support Center (or nearest Sales Office) 2900 Semiconductor Drive P.O. Box 58090 Santa Clara, California 95052-8090 Telephone: 1-800-272-9959	PC87308VUL
PC16550 UART National Semiconductor Corporation Customer Support Center (or nearest Sales Office) 2900 Semiconductor Drive P.O. Box 58090 Santa Clara, California 95052-8090 Telephone: 1-800-272-9959	PC16550DV
MK48T59 CMOS 8K x 8 TIMEKEEPER™ SRAM Data Sheet SGS-Thomson Microelectronics Group Faxback (Document-on-Demand) system Carrollton, TX Telephone: (972) 4667-7788	M48T59
SYM 53CXX (was NCR 53C8XX) Family PCI-SCSI I/O Processors Programming Guide Symbios Logic Inc. 1731 Technology Drive, suite 600 San Jose, CA 95110 Telephone: (408) 441-1080 Hotline: 1-800-334-5454	T72961II
SCC (Serial Communications Controller) User's Manual (for Z85230 and other Zilog parts) Zilog, Inc. 210 East Hacienda Ave., mail stop C1-0 Campbell, California 95008-6600 Telephone: (408) 370-8016 FAX: (408) 370-8056	DC-8293-02

Table A-2. Manufacturers' Documents (Continued)

Document Title and Source	Publication Number
Z8536 CIO Counter/Timer and Parallel I/O Unit Product Specification and User's Manual (in Z8000® Family of Products Data Book) Zilog, Inc. 210 East Hacienda Ave., mail stop C1-0 Campbell, California 95008-6600 Telephone: (408) 370-8016 FAX: (408) 370-8056	DC-8319-00
W83C553 Enhanced System I/O Controller with PCI Arbiter (PIB) Winbond Electronics Corporation Winbond Systems Laboratory 2730 Orchard Parkway San Jose, CA 95134 Telephone: 1-408-943-6666 FAX: 1-408-943-6668	W83C553
Universe User Manual Tundra Semiconductor Corporation 603 March Road Kanata, ON K2K 2M5, Canada Telephone: 1-800-267-7231 Telephone: (613) 592-1320 OR 695 High Glen Drive San Jose, California 95133, USA Telephone: (408) 258-3600 FAX: (408) 258-3659	Universe (Part Number 9000000.MD303.01)

Related Specifications

For additional information, refer to the following table for related specifications. As an additional help, a source for the listed document is also provided. Please note that in many cases, the information is preliminary and the revision levels of the documents are subject to change without notice.

Table A-3. Related Specifications

Document Title and Source	Publication Number
ANSI Small Computer System Interface-2 (SCSI-2), Draft Document Global Engineering Documents 15 Inverness Way East Englewood, CO 80112-5704 Telephone: 1-800-854-7179 Telephone: (303) 792-2181	X3.131.1990
VME64 Specification VITA (VMEbus International Trade Association) 7825 E. Gelding Drive, Suite 104 Scottsdale, Arizona 85260-3415 Telephone: (602) 951-8866 FAX: (602) 951-0720 **NOTE:** An earlier version of this specification is available as:	ANSI/VITA 1-1994
Versatile Backplane Bus: VMEbus Institute of Electrical and Electronics Engineers, Inc. Publication and Sales Department 345 East 47th Street New York, New York 10017-21633 Telephone: 1-800-678-4333 OR Microprocessor system bus for 1 to 4 byte data Bureau Central de la Commission Electrotechnique Internationale 3, rue de Varembé Geneva, Switzerland	ANSI/IEEE Standard 1014-1987 IEC 821 BUS

Table A-3. Related Specifications (Continued)

Document Title and Source	Publication Number
IEEE - Common Mezzanine Card Specification (CMC) Institute of Electrical and Electronics Engineers, Inc. Publication and Sales Department 345 East 47th Street New York, New York 10017-21633 Telephone: 1-800-678-4333	P1386 Draft 2.0
IEEE - PCI Mezzanine Card Specification (PMC) Institute of Electrical and Electronics Engineers, Inc. Publication and Sales Department 345 East 47th Street New York, New York 10017-21633 Telephone: 1-800-678-4333	P1386.1 Draft 2.0
Bidirectional Parallel Port Interface Specification Institute of Electrical and Electronics Engineers, Inc. Publication and Sales Department 345 East 47th Street New York, New York 10017-21633 Telephone: 1-800-678-4333	IEEE Standard 1284
Peripheral Component Interconnect (PCI) Local Bus Specification, Revision 2.0 PCI Special Interest Group 2575 NE Kathryn St #17 Hillsboro, OR 97124 Telephone: (800) 433-5177 (inside the U.S.) or (503) 693-6232 (outside the U.S.) FAX: (503) 693-8344	PCI Local Bus Specification

Table A-3. Related Specifications (Continued)

Document Title and Source	Publication Number
PowerPC™ Microprocessor Common Hardware Reference Platform: A System Architecture (CHRP), Version 1.0 Literature Distribution Center for Motorola Telephone: (800) 441-2447 FAX: (602) 994-6430 or (303) 675-2150 E-mail: ldcformotorola@hibbertco.com OR APDA, Apple Computer, Inc. P.O. Box 319 Buffalo, NY 14207 Telephone: (800) 282-2732 FAX: (716) 871-6511 OR IBM 1580 Route 52, Bldg. 504 Hopewell Junction, NY 12533-6531 Telephone: (800) PowerPC OR Morgan Kaufmann Publishers, Inc. 340 Pine Street, Sixth Floor San Francisco, CA 94104-3205, USA Telephone: (415) 392-2665 FAX: (415) 982-2665	TB338/D MPRPPCHRP-01 ISBN 1-55860-394-8
PowerPC Reference Platform (PRP) Specification, Third Edition, Version 1.0, Volumes I and II International Business Machines Corporation Power Personal Systems Architecture 11400 Burnet Rd. Austin, TX 78758-3493 Document/Specification Ordering Telephone: 1-800-PowerPC Telephone: 1-800-769-3772 Telephone: 708-296-9332	MPR-PPC-RPU-02
ATX Specification Version 2.01 created by Intel Corporation available on the World Wide Web through Teleport Internet Services at URL http://www.teleport.com/~atx/index.htm	

Table A-3. Related Specifications (Continued)

Document Title and Source	Publication Number
IEEE Standard for Local Area Networks: Carrier Sense Multiple Access with Collision Detection (CSMA/CD) Access Method and Physical Layer Specifications Institute of Electrical and Electronics Engineers, Inc. Publication and Sales Department 345 East 47th Street New York, New York 10017-21633 Telephone: 1-800-678-4333	IEEE 802.3
Information Technology - Local and Metropolitan Networks - Part 3: Carrier Sense Multiple Access with Collision Detection (CSMA/CD) Access Method and Physical Layer Specifications Global Engineering Documents 15 Inverness Way East Englewood, CO 80112-5704 Telephone: 1-800-854-7179 Telephone: (303) 792-2181 *(This document can also be obtained through the national standards body of member countries.)*	ISO/IEC 8802-3
Interface Between Data Terminal Equipment and Data Circuit-Terminating Equipment Employing Serial Binary Data Interchange (EIA-232-D) Electronic Industries Association Engineering Department 2001 Eye Street, N.W. Washington, D.C. 20006	ANSI/EIA-232-D Standard

Glossary

Abbreviations, Acronyms, and Terms to Know

This glossary defines some of the abbreviations, acronyms, and key terms used in this document.

10Base-5 An Ethernet implementation in which the physical medium is a doubly shielded, 50-ohm coaxial cable capable of carrying data at 10 Mbps for a length of 500 meters (also referred to as thicknet). Also known as thick Ethernet.

10Base-2 An Ethernet implementation in which the physical medium is a single-shielded, 50-ohm RG58A/U coaxial cable capable of carrying data at 10 Mbps for a length of 185 meters (also referred to as AUI or thinnet). Also known as thin Ethernet.

10Base-T An Ethernet implementation in which the physical medium is an unshielded twisted pair (UTP) of wires capable of carrying data at 10 Mbps for a maximum distance of 185 meters. Also known as twisted-pair Ethernet.

100Base-TX An Ethernet implementation in which the physical medium is an unshielded twisted pair (UTP) of wires capable of carrying data at 100 Mbps for a maximum distance of 100 meters. Also known as fast Ethernet.

ACIA **A**synchronous **C**ommunications **I**nterface **A**dapter

AIX **A**dvanced **I**nteractive e**X**ecutive (IBM version of UNIX)

architecture The main overall design in which each individual hardware component of the computer system is interrelated. The most common uses of this term are 8-bit, 16-bit, or 32-bit architectural design systems.

ASCII **A**merican **S**tandard **C**ode for **I**nformation **I**nterchange. This is a 7-bit code used to encode alphanumeric information. In the IBM-compatible world, this is expanded to 8-bits to encode a total of 256 alphanumeric and control characters.

ASIC **A**pplication-**S**pecific **I**ntegrated **C**ircuit

AUI **A**ttachment **U**nit **I**nterface

BBRAM Battery Backed-up Random Access Memory

bi-endian Having big-endian and little-endian byte ordering capability.

big-endian A byte-ordering method in memory where the address *n* of a word corresponds to the most significant byte. In an addressed memory word, the bytes are ordered (left to right) 0, 1, 2, 3, with 0 being the most significant byte.

BIOS **B**asic **I**nput/**O**utput **S**ystem. This is the built-in program that controls the basic functions of communications between the processor and the I/O (peripherals) devices. Also referred to as ROM BIOS.

BitBLT **Bit** Boundary **BL**ock **T**ransfer. A type of graphics drawing routine that moves a rectangle of data from one area of display memory to another. The data specifically need not have any particular alignment.

BLT **BL**ock **T**ransfer

board The term more commonly used to refer to a PCB (printed circuit board). Basically, a flat board made of nonconducting material, such as plastic or fiberglass, on which chips and other electronic components are mounted. Also referred to as a circuit board or card.

bpi **b**its **p**er **i**nch

bps **b**its **p**er **s**econd

bus The pathway used to communicate between the CPU, memory, and various input/output devices, including floppy and hard disk drives. Available in various widths (8-, 16-, and 32-bit), with accompanying increases in speed.

cache A high-speed memory that resides logically between a central processing unit (CPU) and the main memory. This temporary memory holds the data and/or

instructions that the CPU is most likely to use over and over again and avoids accessing the slower hard or floppy disk drive.

CAS **C**olumn **A**ddress **S**trobe. The clock signal used in dynamic RAMs to control the input of column addresses.

CD **C**ompact **D**isc. A hard, round, flat portable storage unit that stores information digitally.

CD-ROM **C**ompact **D**isk **R**ead-**O**nly **M**emory

CFM **C**ubic **F**eet per **M**inute

CHRP See Common Hardware Reference Platform (CHRP).

CHRP-compliant See Common Hardware Reference Platform (CHRP).

CHRP Spec See Common Hardware Reference Platform (CHRP).

CISC **C**omplex-**I**nstruction-**S**et **C**omputer. A computer whose processor is designed to sequentially run variable-length instructions, many of which require several clock cycles, that perform complex tasks and thereby simplify programming.

CODEC **CO**der/**DEC**oder

Color Difference (CD) The signals of (R-Y) and (B-Y) without the luminance (-Y) signal. The Green signals (G-Y) can be extracted by these two signals.

Common Hardware Reference Platform (CHRP)
A specification published by Apple, IBM, and Motorola which defines the devices, interfaces, and data formats that make up a CHRP-compliant system using a PowerPC processor.

Composite Video Signal (CVS/CVBS)
Signal that carries video picture information for color, brightness and synchronizing signals for both horizontal and vertical scans. Sometimes referred to as “Baseband Video”.

cpi **c**haracters **p**er **i**nch

cpl **c**haracters **p**er **l**ine

CPU **C**entral **P**rocessing **U**nit. The master computer unit in a system.

DCE **D**ata **C**ircuit-terminating **E**quipment.

DLL **D**ynamic **L**ink **L**ibrary. A set of functions that are linked to the referencing program at the time it is loaded into memory.

DMA **D**irect **M**emory **A**ccess. A method by which a device may read or write to memory directly without processor intervention. DMA is typically used by block I/O devices.

DOS **D**isk **O**perating **S**ystem

dpi **d**ots **p**er **i**nch

DRAM **D**ynamic **R**andom **A**ccess **M**emory. A memory technology that is characterized by extreme high density, low power, and low cost. It must be more or less continuously refreshed to avoid loss of data.

DTE **D**ata **T**erminal **E**quipment.

ECC **E**rror **C**orrection **C**ode

ECP **E**xtended **C**apability **P**ort

EEPROM **E**lectrically **E**rasable **P**rogrammable **R**ead-**O**nly **M**emory. A memory storage device that can be written repeatedly with no special erasure fixture. EEPROMs do not lose their contents when they are powered down.

EIDE **E**nhanced **I**ntegrated **D**rive **E**lectronics. An improved version of **IDE**, with faster data rates, 32-bit transactions, and DMA. Also known as **Fast ATA-2**.

EISA (bus) **E**xtended **I**ndustry **S**tandard **A**rchitecture (bus) (IBM). An architectural system using a 32-bit bus that allows data to be transferred between peripherals in 32-bit chunks instead of 16-bit or 8-bit that most systems use. With the transfer of larger bits of information, the machine is able to perform much faster than the standard ISA bus system.

EPP **E**nhanced **P**arallel **P**ort

EPROM — **E**rasable **P**rogrammable **R**ead-**O**nly **M**emory. A memory storage device that can be written once (per erasure cycle) and read many times.

ESCC — **E**nhanced **S**erial **C**ommunication **C**ontroller

ESD — **E**lectro-**S**tatic **D**ischarge/Damage

Ethernet — A local area network standard that uses radio frequency signals carried by coaxial cables.

Falcon — The DRAM controller chip developed by Motorola for the MVME2600 and MVME3600 series of boards. It is intended to be used in sets of two to provide the necessary interface between the Power PC60*x* bus and the 144-bit ECC DRAM (system memory array) and/or ROM/Flash.

fast Ethernet — See 100Base-TX.

FDC — **F**loppy **D**isk **C**ontroller

FDDI — **F**iber **D**istributed **D**ata **I**nterface. A network based on the use of optical-fiber cable to transmit data in non-return-to-zero, invert-on-1s (NRZI) format at speeds up to 100 Mbps.

FIFO — **F**irst-**I**n, **F**irst-**O**ut. A memory that can temporarily hold data so that the sending device can send data faster than the receiving device can accept it. The sending and receiving devices typically operate asynchronously.

firmware — The program or specific software instructions that have been more or less permanently burned into an electronic component, such as a ROM (read-only memory) or an EPROM (erasable programmable read-only memory).

frame — One complete television picture frame consists of 525 horizontal lines with the NTSC system. One frame consists of two Fields.

graphics controller — On EGA and VGA, a section of circuitry that can provide hardware assist for graphics drawing algorithms by performing logical functions on data written to display memory.

HAL — **H**ardware **A**bstraction **L**ayer. The lower level hardware interface module of the Windows NT operating system. It contains platform specific functionality.

hardware A computing system is normally spoken of as having two major components: hardware and software. Hardware is the term used to describe any of the physical embodiments of a computer system, with emphasis on the electronic circuits (the computer) and electromechanical devices (peripherals) that make up the system.

HCT **H**ardware **C**onformance **T**est. A test used to ensure that both hardware and software conform to the Windows NT interface.

I/O **I**nput/**O**utput

IBC PCI/**I**SA **B**ridge **C**ontroller

IDC **I**nsulation **D**isplacement **C**onnector

IDE **I**ntegrated **D**rive **E**lectronics. A disk drive interface standard. Also known as **ATA** (**A**dvanced **T**echnology **A**ttachment).

IEEE **I**nstitute of **E**lectrical and **E**lectronics **E**ngineers

interlaced A graphics system in which the even scanlines are refreshed in one vertical cycle (field), and the odd scanlines are refreshed in another vertical cycle. The advantage is that the video bandwidth is roughly half that required for a non-interlaced system of the same resolution. This results in less costly hardware. It also may make it possible to display a resolution that would otherwise be impossible on given hardware. The disadvantage of an interlaced system is flicker, especially when displaying objects that are only a few scanlines high.

IQ Signals Similar to the color difference signals (R-Y), (B-Y) but using different vector axis for encoding or decoding. Used by some USA TV and IC manufacturers for color decoding.

ISA (bus) **I**ndustry **S**tandard **A**rchitecture (bus). The de facto standard system bus for IBM-compatible computers until the introduction of VESA and PCI. Used in the reference platform specification. (IBM)

ISASIO **ISA** **S**uper **I**nput/**O**utput device

ISDN	**I**ntegrated **S**ervices **D**igital **N**etwork. A standard for digitally transmitting video, audio, and electronic data over public phone networks.
LAN	**L**ocal **A**rea **N**etwork
LED	**L**ight-**E**mitting **D**iode
LFM	**L**inear **F**eet per **M**inute
little-endian	A byte-ordering method in memory where the address *n* of a word corresponds to the least significant byte. In an addressed memory word, the bytes are ordered (left to right) 3, 2, 1, 0, with 3 being the most significant byte.
MBLT	**M**ultiplexed **BL**ock **T**ransfer
MCA (bus)	**M**icro **C**hannel **A**rchitecture
MCG	**M**otorola **C**omputer **G**roup
MFM	**M**odified **F**requency **M**odulation
MIDI	**M**usical **I**nstrument **D**igital **I**nterface. The standard format for recording, storing, and playing digital music.
MPC	**M**ultimedia **P**ersonal **C**omputer
MPC105	The PowerPC-to-PCI bus bridge chip developed by Motorola for the Ultra 603/Ultra 604 system board. It provides the necessary interface between the MPC603/MPC604 processor and the Boot ROM (secondary cache), the DRAM (system memory array), and the PCI bus.
MPC601	Motorola's component designation for the PowerPC 601 microprocessor.
MPC603	Motorola's component designation for the PowerPC 603 microprocessor.
MPC604	Motorola's component designation for the PowerPC 604 microprocessor.
MPIC	**M**ulti-**P**rocessor **I**nterrupt **C**ontroller
MPU	**M**icro**P**rocessing **U**nit
MTBF	**M**ean **T**ime **B**etween **F**ailures. A statistical term relating to reliability as expressed in power on hours (poh). It was originally developed for the military and can be calculated

	several different ways, yielding substantially different results. The specification is based on a large number of samplings in one place, running continuously, and the rate at which failure occurs. MTBF is not representative of how long a device, or any individual device is likely to last, nor is it a warranty, but rather, a gauge of the relative reliability of a family of products.
multisession	The ability to record additional information, such as digitized photographs, on a CD-ROM after a prior recording session has ended.
non-interlaced	A video system in which every pixel is refreshed during every vertical scan. A non-interlaced system is normally more expensive than an interlaced system of the same resolution, and is usually said to have a more pleasing appearance.
nonvolatile memory	A memory in which the data content is maintained whether the power supply is connected or not.
NTSC	**N**ational **T**elevision **S**tandards **C**ommittee (USA)
NVRAM	**N**on-**V**olatile **R**andom **A**ccess **M**emory
OEM	**O**riginal **E**quipment **M**anufacturer
OMPAC	**O**ver - **M**olded **P**ad **A**rray **C**arrier
OS	**O**perating **S**ystem. The software that manages the computer resources, accesses files, and dispatches programs.
OTP	**O**ne-**T**ime **P**rogrammable
palette	The range of colors available on the screen, not necessarily simultaneously. For VGA, this is either 16 or 256 simultaneous colors out of 262,144.
parallel port	A connector that can exchange data with an I/O device eight bits at a time. This port is more commonly used for the connection of a printer to a system.
PCI (local bus)	**P**eripheral **C**omponent **I**nterconnect (local bus) (Intel). A high-performance, 32-bit internal interconnect bus used for data transfer to peripheral controller components, such as those for audio, video, and graphics.

PCMCIA (bus) — **P**ersonal **C**omputer **M**emory **C**ard **I**nternational **A**ssociation (bus). A standard external interconnect bus which allows peripherals adhering to the standard to be plugged in and used without further system modification.

PCR — **P**CI **C**onfiguration **R**egister

PDS — **P**rocessor **D**irect **S**lot

PHB — **P**CI **H**ost **B**ridge

physical address — A binary address that refers to the actual location of information stored in secondary storage.

PIB — **P**CI-to-**I**SA **B**ridge

pixel — An acronym for picture element, and is also called a pel. A pixel is the smallest addressable graphic on a display screen. In RGB systems, the color of a pixel is defined by some Red intensity, some Green intensity, and some Blue intensity.

PLL — **P**hase-**L**ocked **L**oop

PMC — **P**CI **M**ezzanine **C**ard

POWER — **P**erformance **O**ptimized **W**ith **E**nhanced **R**ISC architecture (IBM)

PowerPC™ — The trademark used to describe the **P**erformance **O**ptimized **W**ith **E**nhanced **R**ISC microprocessor architecture for **P**ersonal **C**omputers developed by the IBM Corporation. PowerPC is superscalar, which means it can handle more than one instruction per clock cycle. Instructions can be sent simultaneously to three types of independent execution units (branch units, fixed-point units, and floating-point units), where they can execute concurrently, but finish out of order. PowerPC is used by Motorola, Inc. under license from IBM.

PowerPC 601™ — The first implementation of the PowerPC family of microprocessors. This CPU incorporates a memory management unit with a 256-entry buffer and a 32KB unified (instruction and data) cache. It provides a 64-bit data bus and a separate 32-bit address bus. PowerPC 601 is used by Motorola, Inc. under license from IBM.

PowerPC 603™ The second implementation of the PowerPC family of microprocessors. This CPU incorporates a memory management unit with a 64-entry buffer and an 8KB (instruction and data) cache. It provides a selectable 32-bit or 64-bit data bus and a separate 32-bit address bus. PowerPC 603 is used by Motorola, Inc. under license from IBM.

PowerPC 604™ The third implementation of the PowerPC family of microprocessors currently under development. PowerPC 604 is used by Motorola, Inc. under license from IBM.

PowerPC Reference Platform (PRP) A specification published by the IBM Power Personal Systems Division which defines the devices, interfaces, and data formats that make up a PRP-compliant system using a PowerPC processor.

PowerStack™ RISC PC (System Board) A PowerPC-based computer board platform developed by the Motorola Computer Group. It supports Microsoft's Windows NT and IBM's AIX operating systems.

PRP See PowerPC Reference Platform (PRP).

PRP-compliant See PowerPC Reference Platform (PRP).

PRP Spec See PowerPC Reference Platform (PRP).

PROM **P**rogrammable **R**ead-**O**nly **M**emory

PS/2 **P**ersonal **S**ystem/**2** (IBM)

QFP **Q**uad **F**lat **P**ackage

RAM **R**andom-**A**ccess **M**emory. The temporary memory that a computer uses to hold the instructions and data currently being worked with. All data in RAM is lost when the computer is turned off.

RAS **R**ow **A**ddress **S**trobe. A clock signal used in dynamic RAMs to control the input of the row addresses.

Raven The PowerPC-to-PCI local bus bridge chip developed by Motorola for the MVME2600 and MVME3600 series of boards. It provides the necessary interface between the PowerPC 60x bus and the PCI bus, and acts as interrupt controller.

Reduced-Instruction-Set Computer (RISC) A computer in which the processor's instruction set is limited to constant-length instructions that can usually be executed in a single clock cycle.

RFI **R**adio **F**requency **I**nterference

RGB The three separate color signals: **R**ed, **G**reen, and **B**lue. Used with color displays, an interface that uses these three color signals as opposed to an interface used with a monochrome display that requires only a single signal. Both digital and analog RGB interfaces exist.

RISC See Reduced Instruction Set Computer (RISC).

ROM **R**ead-**O**nly **M**emory

RTC **R**eal-**T**ime **C**lock

SBC **S**ingle **B**oard **C**omputer

SCSI **S**mall **C**omputer **S**ystems **I**nterface. An industry-standard high-speed interface primarily used for secondary storage. SCSI-1 provides up to 5 Mbps data transfer.

SCSI-2 (Fast/Wide) An improvement over plain SCSI; and includes command queuing. Fast SCSI provides 10 Mbps data transfer on an 8-bit bus. Wide SCSI provides up to 40 Mbps data transfer on a 16- or 32-bit bus.

serial port A connector that can exchange data with an I/O device one bit at a time. It may operate synchronously or asynchronously, and may include start bits, stop bits, and/or parity.

SIM **S**erial **I**nterface **M**odule

SIMM **S**ingle **I**nline **M**emory **M**odule. A small circuit board with RAM chips (normally surface mounted) on it designed to fit into a standard slot.

SIO	**S**uper **I/O** controller
SMP	**S**ymmetric **M**ulti**P**rocessing. A computer architecture in which tasks are distributed among two or more local processors.
SMT	**S**urface **M**ount **T**echnology. A method of mounting devices (such as integrated circuits, resistors, capacitors, and others) on a printed circuit board, characterized by not requiring mounting holes. Rather, the devices are soldered to pads on the printed circuit board. Surface-mount devices are typically smaller than the equivalent through-hole devices.
software	A computing system is normally spoken of as having two major components: hardware and software. Software is the term used to describe any single program or group of programs, languages, operating procedures, and documentation of a computer system. Software is the real interface between the user and the computer.
SRAM	**S**tatic **R**andom **A**ccess **M**emory
SSBLT	**S**ource **S**ynchronous **BL**ock **T**ransfer
standard(s)	A set of detailed technical guidelines used as a means of establishing uniformity in an area of hardware or software development.
SVGA	**S**uper **V**ideo **G**raphics **A**rray (IBM). An improved VGA monitor standard that provides at least 256 simultaneous colors and a screen resolution of 800 x 600 pixels.
Teletext	One way broadcast of digital information. The digital information is injected in the broadcast TV signal, VBI, or full field, The transmission medium could be satellite, microwave, cable, etc. The display medium is a regular TV receiver.
thick Ethernet	See 10base-5.
thin Ethernet	See 10base-2.
twisted-pair Ethernet	See 10Base-T.
UART	**U**niversal **A**synchronous **R**eceiver/**T**ransmitter

Universe ASIC developed by Tundra in consultation with Motorola, that provides the complete interface between the PCI bus and the 64-bit VMEbus.

UV **U**ltra**V**iolet

UVGA **U**ltra **V**ideo **G**raphics **A**rray. An improved VGA monitor standard that provides at least 256 simultaneous colors and a screen resolution of 1024 x 768 pixels.

Vertical Blanking Interval (VBI) The time it takes the beam to fly back to the top of the screen in order to retrace the opposite field (odd or even). VBI is in the order of 20 TV lines. Teletext information is transmitted over 4 of these lines (lines 14-17).

VESA (bus) **V**ideo **E**lectronics **S**tandards **A**ssociation (or VL bus). An internal interconnect standard for transferring video information to a computer display system.

VGA **V**ideo **G**raphics **A**rray (IBM). The third and most common monitor standard used today. It provides up to 256 simultaneous colors and a screen resolution of 640 x 480 pixels.

virtual address A binary address issued by a CPU that indirectly refers to the location of information in primary memory, such as main memory. When data is copied from disk to main memory, the physical address is changed to the virtual address.

VL bus See **V**ESA **L**ocal bus (VL bus).

VMEchip2 MCG second generation VMEbus interface ASIC (Motorola)

VME2PCI MCG ASIC that interfaces between the PCI bus and the VMEchip2 device.

volatile memory A memory in which the data content is lost when the power supply is disconnected.

VRAM **V**ideo (Dynamic) **R**andom **A**ccess **M**emory. Memory chips with two ports, one used for random accesses and the other capable of serial accesses. Once the serial port has been initialized (with a transfer cycle), it can operate independently of the random port. This frees the random

port for CPU accesses. The result of adding the serial port is a significantly reduced amount of interference from screen refresh. VRAMs cost more per bit than DRAMs.

Windows NT™ The trademark representing **Windows N**ew **T**echnology, a computer operating system developed by the Microsoft Corporation.

XGA E**X**tended **G**raphics **A**rray. An improved IBM VGA monitor standard that provides at least 256 simultaneous colors and a screen resolution of 1024 x 768 pixels.

Y Signal Luminance. This determines the brightness of each spot (pixel) on a CRT screen either color or B/W systems, but not the color.

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